



## TEST REPORT



Applicant	Shenzhen SOFAR SOLAR Co., Ltd.
Address	401, Building 4, AnTongDa Industrial Park, District 68, XingDong Community, XinAn Street, BaoAn District, Shenzhen, China.

Manufacturer or Supplier	Shenzhen SOFAR SOLAR Co., Ltd.	
Address	401, Building 4, AnTongDa Industrial Park, District 68, XingDong Community, XinAn Street, BaoAn District, Shenzhen, China.	
Product	Solar Grid-tied Inverter	
Brand Name		
Model	SOFAR 3000TL, SOFAR 1100TL	
Additional Model & Model Difference	SOFAR 2200TL, SOFAR 1600TL, SOFAR 2700TL, See items 2.1	
Date of tests	May 08, 2020 ~ May 25, 2020	

The submitted sample of the above equipment has been tested according to the requirements of the following standards:

- EN 61000-6-3:2007+A1:2011+AC:2012
- EN IEC 61000-3-2:2019
- EN 61000-3-3:2013+A1:2019
- EN 61000-6-2:2005

**CONCLUSION: The submitted sample was found to COMPLY with the test requirement**

Tested by Ryan Lu Project Engineer / EMC Department	Approved by Glyn He Assistant Manager / EMC Department
	 Date: May 28, 2020

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## RELEASE CONTROL RECORD

ISSUE NO.	REASON FOR CHANGE	DATE ISSUED
CE200423N070	Original release	May 28, 2020



## 1 SUMMARY OF TEST RESULTS

The EUT has been tested according to the following specifications:

EMISSION			
Standard	Test Type	Result	Remark
EN61000-6-3:2007+A1: 2011+AC:2012	Conducted test	PASS	Meets Limits Minimum passing margin is -2.24 dB at 0.47813 MHz
	Radiated test (30MHz~1GHz)	PASS	Meets limits minimum passing margin is -3.60 dB at 32.1700 MHz
EN IEC 61000-3-2:2019	Harmonic current emissions	PASS	Meets the requirements.
EN 61000-3-3:2013+A1:2019	Voltage fluctuations & flicker	PASS	Meets the requirements.

<b>IMMUNITY (EN 61000-6-2:2005)</b>			
<b>Standard</b>	<b>Test Type</b>	<b>Result</b>	<b>Remark</b>
IEC 61000-4-2:2008 ED. 2.0	Electrostatic discharge immunity test	PASS	Electrostatic Discharge – ESD: 8kV Air discharge, 4kV Contact discharge, Performance Criterion A
IEC 61000-4-3:2010 ED. 3.2	Radiated, radio-frequency, electromagnetic field immunity test	PASS	Radio-Frequency Electromagnetic Field Susceptibility Test – RS: 80-1000 MHz, 10V/m, 80% AM (1kHz), 1400-2000 MHz, 3V/m, 80% AM (1kHz) 2000-2700 MHz, 1V/m, 80% AM (1kHz) Performance Criterion A
IEC 61000-4-4:2012 ED. 3.0	Electrical fast transient / burst immunity test.	PASS	Electrical Fast Transient/Burst - EFT AC Power line: 2kV, DC Power line: 2kV, Performance Criterion A
IEC 61000-4-5:2017 ED. 3.1	Surge immunity test	PASS	Surge Immunity Test: 1.2/50 us Open Circuit Voltage, 8 /20 us Short Circuit Current, AC Power Line: line to line 1 kV, line to earth 2kV DC Power Line: line to line 0.5kV Performance Criterion A
IEC 61000-4-6:2013 ED. 4.0	Immunity to conducted disturbances, induced by radio-frequency fields	PASS	Conducted Radio Frequency Disturbances Test – CS: 0.15-80 MHz, 3Vrms, 80% AM, 1kHz, Performance Criterion A
IEC 61000-4-8:2009 ED. 2.0	Power frequency magnetic field immunity test.	PASS	Power Frequency Magnetic Field Test, 50/60Hz, 30A/m, Performance Criterion A



## 1.1 MEASUREMENT UNCERTAINTY

Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the EUT as specified in CISPR 16-4-2:

This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of  $k=2$ .

MEASUREMENT	FREQUENCY	UNCERTAINTY
Mains Terminal Disturbance Voltage Test	0.15MHz ~ 30MHz	+ /-2.70 dB
Radiated Disturbance Test	30MHz ~ 1000MHz	+ /-3.99 dB





## 2 GENERAL INFORMATION

### 2.1 GENERAL DESCRIPTION OF EUT

<b>PRODUCT</b>	Solar Grid-tied Inverter
<b>MODEL NO.</b>	SOFAR 3000TL, SOFAR 1100TL
<b>ADDITIONAL MODEL</b>	SOFAR 1600TL, SOFAR 2700TL, SOFAR 2200TL
<b>POWER SUPPLY</b>	DC Input: DC 90 - 450V Max. 10A For SOFAR 1100TL; DC Input: DC 90 - 450V Max. 10A For SOFAR 1600TL ; DC Input: DC 100 - 500V Max. 13A For SOFAR 2200TL; DC Input: DC 100 - 500V Max. 13A For SOFAR 2700TL; DC Input: DC 100 - 500V Max. 13A For SOFAR 3000TL Output: SOFAR 1100TL: AC 230V 50/60Hz 6.8A 1500W SOFAR 1600TL:AC 230V 50/60Hz 7.0A 1550W SOFAR 2200TL:AC 230V 50/60Hz 9.5A 2100W SOFAR 2700TL:AC 230V 50/60Hz 11.5A 2500W SOFAR 3000TL:AC 230V 50/60Hz 13.0A 2800W
<b>THE HIGHEST OPERATING FREQUENCY</b>	Below 108MHz
<b>CABLE SUPPLIED</b>	N/A

#### NOTE:

1. For the test results, the EUT had been tested with all conditions. But only the worst case was showed in test report.
2. For a more detailed features description, please refer to the manufacturer's specifications or the User's Manual.
3. RS485 port on the product is for client to collect data, according to client requirements, no need to test.
4. All models shell include red, blue, white and other colors. All models of DC switch and WIFI module is optional accessories, optional installation according to the need of client.

5. This is a series of PV Grid Inverter with the same as in hardware except the amount of BUS capacitor, inverter inductor, Boost and IGBT component and DC switch are different. Identical in software the output power just adjusted by software; models SOFAR 3000TL, SOFAR 1100TL are selected to test. full test was performed for the model SOFAR 3000TL, and partial test for the models SOFAR 1100TL test CE,RE.

<b>Ratings .....</b>	SOFAR 1100TL	SOFAR 1600TL	SOFAR 2200TL	SOFAR 2700TL	SOFAR 3000TL
Input DC voltage range [V]..... :	90-450	90-450	100-500	100-500	100-500
MPP DC voltage range[V] .....	155-380	160-380	165-450	205-450	225-455
Max. Input DC current [A]..... :	10		13		
Output AC voltage[V]..... :	230V, 50/60Hz				
Max. Output AC current [A] .....	6.8	7.0	9.5	11.5	13.0
Output power [W] .....	1500	1550	2100	2500	2800

**6. Model Difference:**

<b>Difference:</b>	SOFAR 3000TL	SOFAR 2700TL	SOFAR 2200TL	SOFAR 1600TL	SOFAR 1100TL
Boost inductor	1.9mH	1.9mH	1.9mH	2.6mH	2.6mH
Input sampling resistor (RP105,RP108 /RP189,RP109)	200ohm / 7.5Kohm	200ohm / 7.5Kohm	200ohm / 7.5Kohm	220ohm / 10Kohm	220ohm / 10Kohm
Bus capacitor	3pcs	3pcs	3pcs	2pcs	2pcs
Inverter inductor	1.3mH	1.3mH	1.3mH	2.3mH	3.4mH
Output sampling resistor (RP118, RP119, RC18 /RP120, RP121,RC22)	2Kohm,100ohm,100ohm	2Kohm,100ohm,100ohm	2Kohm,100ohm,100ohm	1.0Kohm,200ohm,100ohm	499ohm,200ohm,200ohm



## 2.2 DESCRIPTION OF TEST MODES

The EUT were tested under the following modes, the final worst mode was marked in boldface and recorded in this report.

### CONDUCTED EMISSION TEST:

Test Mode	Test Model	Test Voltage
<b>Grid Mode (Full load)</b>	<b>SOFAR 3000TL</b>	Input 225VDC Output 230VAC 50Hz Input 330VDC Output 230VAC 50Hz <b>Input 455VDC Output 230VAC 50Hz</b>
	SOFAR 1100TL	Input 155VDC Output 230VAC 50Hz Input 270VDC Output 230VAC 50Hz Input 380VDC Output 230VAC 50Hz

### RADIATED EMISSION TEST:

Test Mode	Test Model	Test Voltage
<b>Grid Mode (Full load)</b>	<b>SOFAR 3000TL</b>	Input 225VDC Output 230VAC 50Hz <b>Input 330VDC Output 230VAC 50Hz</b> Input 455VDC Output 230VAC 50Hz
	SOFAR 1100TL	Input 155VDC Output 230VAC 50Hz Input 270VDC Output 230VAC 50Hz Input 380VDC Output 230VAC 50Hz

### FOR HARMONICS AND FLICKER TEST:

Test Mode	Test Model	Test Voltage
<b>Grid Mode (Full load)</b>	<b>SOFAR 3000TL</b>	<b>Input 455VDC Output 230VAC 50Hz</b>

### IMMUNITY TESTS:

Test Mode	Test Model	Test Voltage
<b>Grid Mode (10% load)</b>	<b>SOFAR 3000TL</b>	<b>Input 455VDC Output 230VAC 50Hz</b>



### 2.3 GENERAL DESCRIPTION OF APPLIED STANDARDS

The EUT has been tested and complied with the requirements of the following standards:

**EN 61000-6-3:2007+A1:2011+AC:2012**

**EN IEC 61000-3-2:2019**

**EN 61000-3-3:2013+A1:2019**

**EN 61000-6-2:2005**

IEC 61000-4-2:2008 ED. 2.0

IEC 61000-4-3:2010 ED. 3.2

IEC 61000-4-4:2012 ED. 3.0

IEC 61000-4-5:2017 ED. 3.1

IEC 61000-4-6:2013 ED. 4.0

IEC 61000-4-8:2009 ED. 2.0

**NOTE:** The above IEC basic standards are applied with latest version if customer has no special requirement.

### 2.4 DESCRIPTION OF SUPPORT UNITS

The EUT has been tested as an independent unit together with other necessary accessories or support units. The following support units or accessories were used to form a representative test configuration during the tests.

NO.	PRODUCT	BRAND	MODEL NO.	SERIAL NO.	FCC ID
1	DC Source	Chroma	62150H-1000S	62150EF00488	N/A

NO.	SIGNAL CABLE DESCRIPTION OF THE ABOVE SUPPORT UNITS
1	AC Line: Unshielded, Detachable 2.0m, DC Line: Unshielded, Detachable 2.0m;



### 3 EMISSION TEST

#### 3.1 CONDUCTED EMISSION MEASUREMENT

##### 3.1.1 LIMITS OF CONDUCTED EMISSION MEASUREMENT

FREQUENCY (MHz)	dBuV	
	Quasi-peak	Average
0.15 - 0.5	66 - 56	56 - 46
0.50 - 5.0	56	46
5.0 - 30.0	60	50

- Note:** (1) The lower limit shall apply at the transition frequencies.  
(2) The limit decreases in line with the logarithm of the frequency in the range of 0.15 to 0.50 MHz.

##### 3.1.2 TEST INSTRUMENTS

Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Next Cal.
EMI Test Receiver	Rohde&Schwarz	ESCS30	100199	Mar. 18,20	Mar. 17,21
Pulse Limiter	Rohde&Schwarz	ESH3-Z2	100168	Sep. 18,19	Sep. 17,20
Artificial Mains Network	Rohde&Schwarz	ESH2-Z5	100071	Mar. 25,20	Mar. 24,21
Artificial Mains Network	SCHWARZBEC K	NNLK 8129	8129-264	Mar. 18,20	Mar. 17,21
Voltage probe	SCHWARZBEC K	TK 9421	TK 9421-176	Sep. 24,19	Sep. 23,20
Test software	ADT	ADT_Cond_ V7.3.7	N/A	N/A	N/A

- NOTE:** 1. The test was performed in shielded room 843.  
2. The calibration interval of the above test instruments is 12 months. And the calibrations are traceable to CEPREI/CHINA, GRGT/CHINA and NIM/CHINA.



### 3.1.3 TEST PROCEDURE

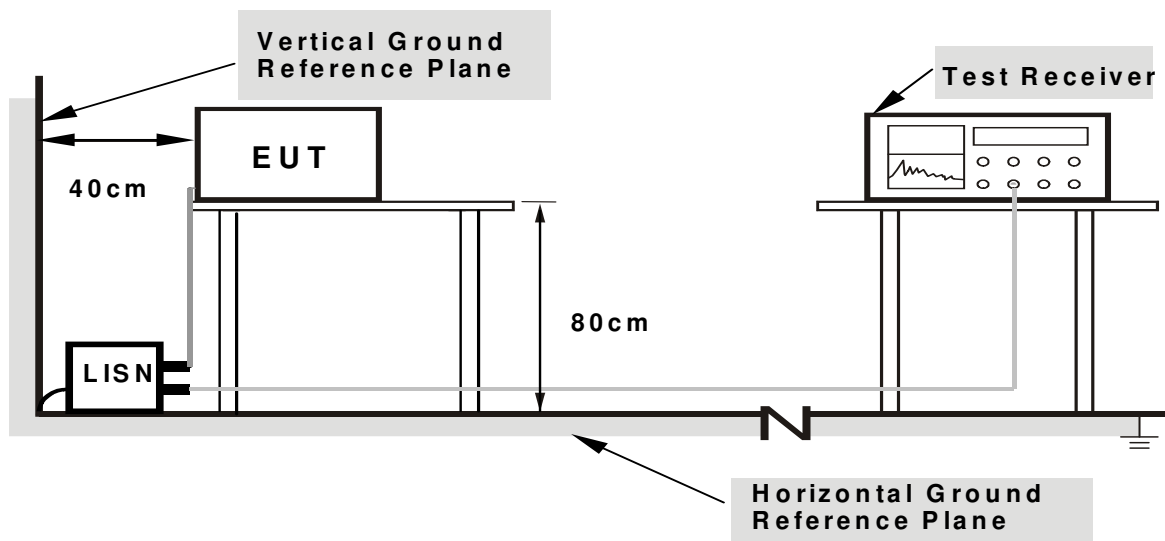
- a. The EUT was placed 0.4 meters from the conducting wall of the shielded room with EUT being connected to the power mains through a line impedance stabilization network (LISN). Other support units were connected to the power mains through another LISN. The two LISNs provide 50 Ohm/ 50uH of coupling impedance for the measuring instrument.
- b. Both lines of the power mains connected to the EUT were checked for maximum conducted interference.
- c. The frequency range from 150 kHz to 30 MHz was searched. Emission levels under (Limit – 20dB) were not recorded.

### 3.1.4 DEVIATION FROM TEST STANDARD

No deviation



### 3.1.5 TEST SETUP



- Note:**
1. Support units were connected to second LISN.
  2. Both of LISNs (AMN) are 80cm from EUT and at least 80cm from other units and other metal planes support units.

### 3.1.6 EUT OPERATING CONDITIONS

- a. Turned on the power of all equipment.
- b. EUT was operated according to the type description in manufacturer's specifications or the User's Manual.

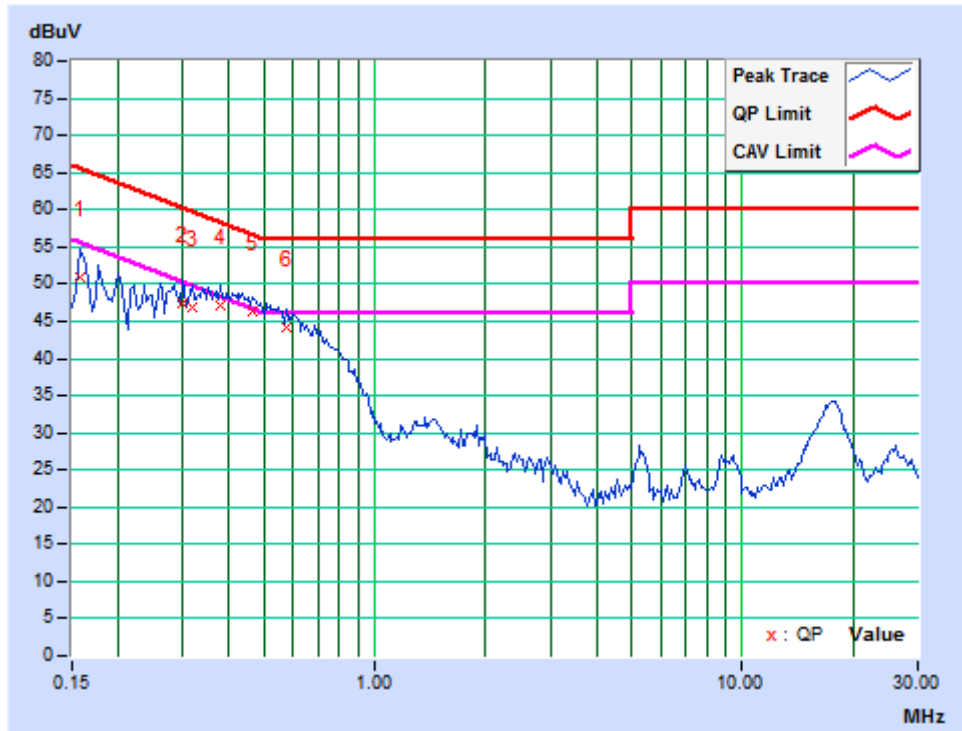


### 3.1.7 TEST RESULTS

<b>TEST MODE</b>	See section 2.2	<b>6dB BANDWIDTH</b>	9 kHz
<b>TEST VOLTAGE</b>	See section 2.2	<b>PHASE</b>	Line (L)
<b>ENVIRONMENTAL CONDITIONS</b>	25deg. C, 46% RH		<b>TESTED BY:</b> Wang

No	Freq. [MHz]	Corr. Factor (dB)	Reading Value		Emission Level		Limit		Margin	
			[dB (uV)]		[dB (uV)]		[dB (uV)]		(dB)	
			Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.
1	0.15781	9.05	41.94	37.64	50.99	46.69	65.58	55.58	-14.58	-8.88
2	0.29844	9.69	37.75	34.21	47.44	43.90	60.29	50.29	-12.85	-6.39
3	0.31797	9.69	37.09	34.22	46.78	43.91	59.76	49.76	-12.98	-5.85
4	0.38047	9.69	37.32	34.00	47.01	43.69	58.27	48.27	-11.26	-4.58
5	0.46250	9.71	36.49	33.19	46.20	42.90	56.65	46.65	-10.45	-3.75
6	0.57188	9.69	34.61	31.50	44.30	41.19	56.00	46.00	-11.70	-4.81

**REMARK:** The emission levels of other frequencies were very low against the limit.

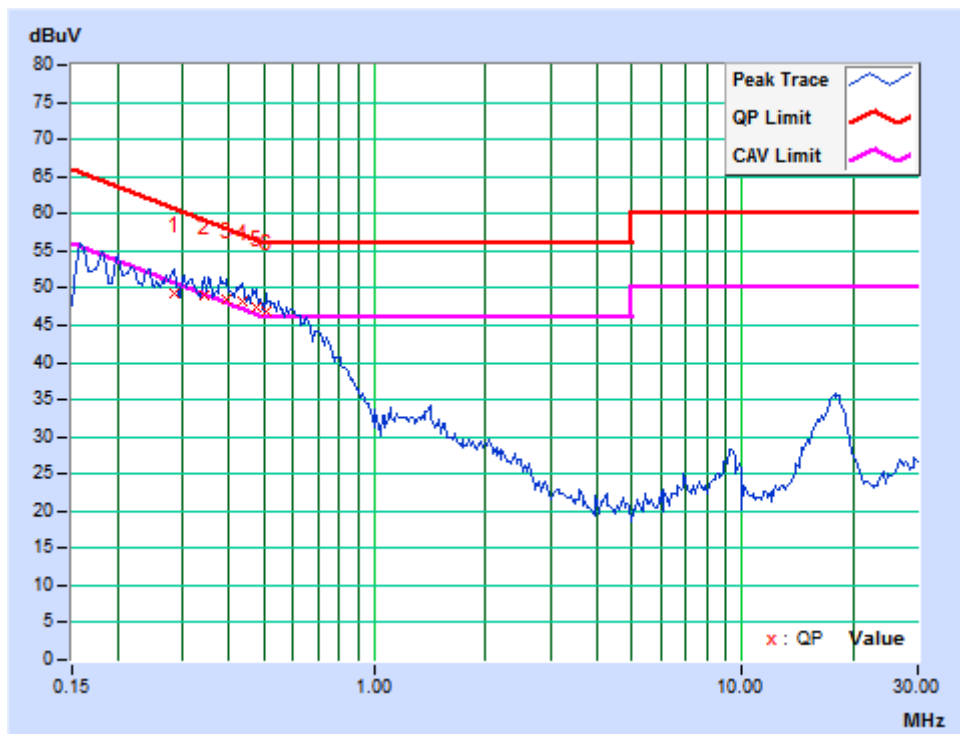




<b>TEST MODE</b>	See section 2.2	<b>6dB BANDWIDTH</b>	9 kHz
<b>TEST VOLTAGE</b>	See section 2.2	<b>PHASE</b>	Neutral (N)
<b>ENVIRONMENTAL CONDITIONS</b>	25deg. C, 46% RH	<b>TESTED BY:</b> Wang	

No	Freq. [MHz]	Corr. Factor (dB)	Reading Value		Emission Level		Limit		Margin	
			[dB (uV)]		[dB (uV)]		[dB (uV)]		(dB)	
			Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.
1	0.28281	9.75	39.48	35.82	49.23	45.57	60.73	50.73	-11.50	-5.16
2	0.34141	9.76	39.22	35.55	48.98	45.31	59.17	49.17	-10.19	-3.86
3	0.39609	9.75	38.76	35.24	48.51	44.99	57.93	47.93	-9.42	-2.94
4	0.43516	9.77	38.37	34.77	48.14	44.54	57.15	47.15	-9.01	-2.61
<b>5</b>	<b>0.47813</b>	<b>9.77</b>	<b>37.64</b>	<b>34.36</b>	<b>47.41</b>	<b>44.13</b>	<b>56.37</b>	<b>46.37</b>	<b>-8.96</b>	<b>-2.24</b>
6	0.50547	9.76	37.11	33.96	46.87	43.72	56.00	46.00	-9.13	-2.28

**REMARK:** The emission levels of other frequencies were very low against the limit.





### 3.2 RADIATED EMISSION MEASUREMENT

#### 3.2.1 LIMITS OF RADIATED EMISSION MEASUREMENT

**TEST STANDARD: EN 61000-6-3**

**FOR FREQUENCY BELOW 1000 MHz**

FREQUENCY (MHz)	3m	10m
	Quasi-Peak(dBuV/m)	Quasi-Peak (dBuV/m)
30 – 230	40	30
230 – 1000	47	37

#### FREQUENCY RANGE OF RADIATED MEASUREMENT

(For unintentional radiators)

Highest frequency generated or Upper frequency of measurement used in the device or on which the device operates or tunes (MHz)	Range (MHz)
Below 108	1000
108 – 500	2000
500 – 1000	5000
Above 1000	Up to 5 times of the highest frequency or 6 GHz, whichever is less

**FOR FREQUENCY ABOVE 1000 MHz**

FREQUENCY (GHz)	3m	
	PEAK(dBuV/m)	AVERAGE(dBuV/m)
1 to 3	70	50
3 to 6	74	54

**NOTE:** (1) The lower limit shall apply at the transition frequencies.  
(2) Emission level (dBuV/m) = 20 log Emission level (uV/m).



### 3.2.2 TEST INSTRUMENTS

#### FOR FREQUENCY BELOW 1GHz

Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Next Cal.
EMI Test Receiver	Rohde&Schwarz	ESU26	100005	May 14, 20	May 13, 21
EMI Test Receiver	Rohde&Schwarz	ESR7	101564	Mar. 18,20	Mar. 17,21
Trilog-Broadband Antenna	SCHWARZBECK	VULB 9168	9168-555	Nov. 24, 19	Nov. 23, 20
Trilog-Broadband Antenna	SCHWARZBECK	VULB 9168	9168-554	Dec. 01, 19	Nov. 30, 20
Preamplifier	EMCI	EMC1135	980378	Mar. 15,20	Mar. 14,21
Preamplifier	EMCI	EMC1135	980423	Mar. 15,20	Mar. 14,21
10m Semi-anechoic Chamber	CHANGLING	21.4m*12.1m*8.8m	NSEMC006	Oct. 19,19	Oct. 18,20
Test Software	ADT	ADT_Radiated_V8.7.07	N/A	N/A	N/A

- NOTE:** 1. The test was performed in 10m Chamber.  
 2. The calibration interval of the above test instruments is 12 months. And the calibrations are traceable to CEPREI/CHINA, GRGT/CHINA and NIM/CHINA

#### FOR FREQUENCY ABOVE 1GHz

Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Next Cal.
Horn Antenna	ETS-Lindgren	3117	00085519	Nov. 24, 19	Nov. 23, 20
Horn Antenna	SCHWARZBECK	BBHA 9170	BBHA9170147	May 10,20	May 09,21
Signal and Spectrum Analyzer	Rohde&Schwarz	FSV40	101003	Mar. 18,20	Mar. 17,21
Broadband Preamplifier (1~18GHz)	SCHWARZBECK	BBV9718	266	May 09,20	May 08,21
Pre-Amplifier (18GHz-40GHz)	EMCI	EMC 184045	980102	Mar. 04,20	Mar. 03,21
Test Software	ADT	ADT_Radiated_V8.7.07	N/A	N/A	N/A

- NOTE:** 1. The test was performed in 10m Chamber.  
 2. The calibration interval of the above test instruments is 12 months. And the calibrations are traceable to CEPREI/CHINA, GRGT/CHINA and NIM/CHINA.



### 3.2.3 TEST PROCEDURE

#### <Frequency Range below 1GHz>

- a. The EUT was placed on the top of a rotating table 0.8 meters above the ground at a 10 meter chamber room. The table was rotated 360 degrees to determine the position of the highest radiation.
- b. The EUT was set 10 meters away from the interference-receiving antenna, which was mounted on the top of a variable-height antenna tower.
- c. The height of antenna is varied from one meter to four meters above the ground to determine the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- d. For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights from 1 meter to 4 meters and the turn table was turned from 0 degrees to 360 degrees to find the maximum reading.
- e. The test-receiver system was set to quasi-peak detect function and specified bandwidth with maximum hold mode when the test frequency is below 1 GHz.

#### NOTE:

1. The resolution bandwidth of test receiver/spectrum analyzer is 120kHz for Quasi-peak detection (QP) at frequency below 1GHz.
2. Emission level(dBuV/m)=Raw Value(dBuV) + Correction Factor(dB/m)
3. Correction Factor(dB/m) = Antenna Factor (dB/m) + Cable Factor (dB) (if the raw value not contains the amplifier);
4. Correction Factor(dB/m) = Antenna Factor (dB/m) + Cable Factor (dB) – Amplifier Gain(dB) (if the raw value contains the amplifier).
5. Margin value = Emission level – Limit value.



### <Frequency Range above 1GHz>

- a. The EUT was placed on the top of a rotating table 0.8 meters above the ground at a 10 meter Semi-anechoic chamber room. The table was rotated 360 degrees to determine the position of the highest radiation.
- b. The EUT was set 3 meters away from the interference-receiving antenna, which was mounted on the top of a variable-height antenna tower.
- c. The height of antenna can be varied from one meter-to four meters, the height of adjustment depends on the EUT height and the antenna 3dB beamwidth both, to detect the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement. The bore sight should be used during the test above 1GHz.
- d. For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights and the rotatable table was turned from 0 degrees to 360 degrees to find the maximum reading.
- e. The test receiver/spectrum was set to peak and average detect function and specified bandwidth with maximum hold mode when the test frequency is above 1 GHz.

#### NOTE:

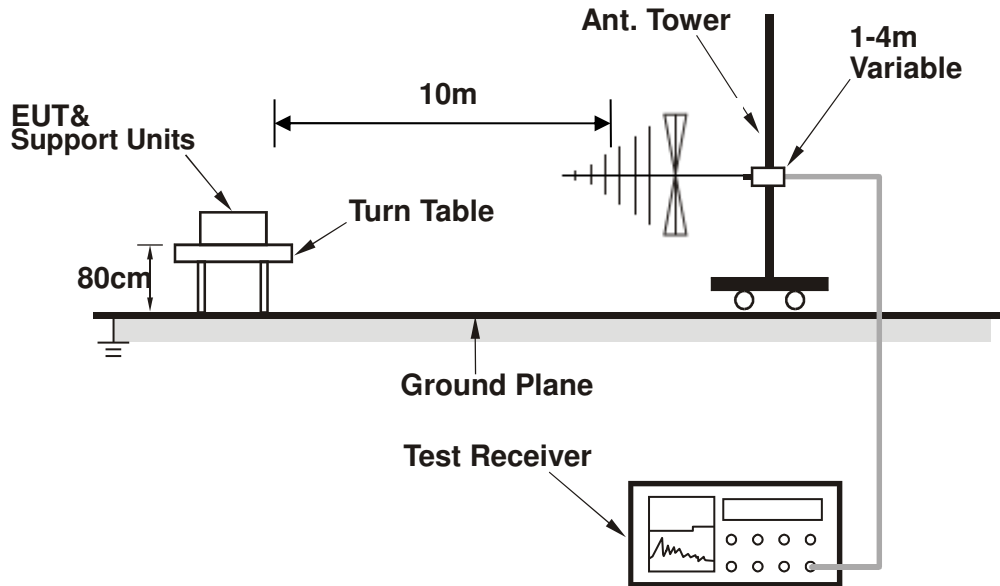
1. The resolution bandwidth is 1MHz and video bandwidth of test receiver/spectrum analyzer is 3MHz for Peak detection at frequency above 1GHz. The resolution bandwidth of test receiver/spectrum analyzer is 1 MHz for Average detection (AV) at frequency above 1GHz.
2. For measurement of frequency above 1000 MHz, the EUT was set 3 meters away from the receiver antenna.
3.  $\text{Emission level(dBuV/m)} = \text{Raw Value(dBuV)} + \text{Correction Factor(dB/m)}$
4.  $\text{Correction Factor(dB/m)} = \text{Antenna Factor (dB/m)} + \text{Cable Factor (dB)}$  (if the raw value not contains the amplifier);
5.  $\text{Correction Factor(dB/m)} = \text{Antenna Factor (dB/m)} + \text{Cable Factor (dB)} - \text{Amplifier Gain(dB)}$  (if the raw value contains the amplifier).
6.  $\text{Margin value} = \text{Emission level} - \text{Limit value}$ .

### 3.2.4 DEVIATION FROM TEST STANDARD

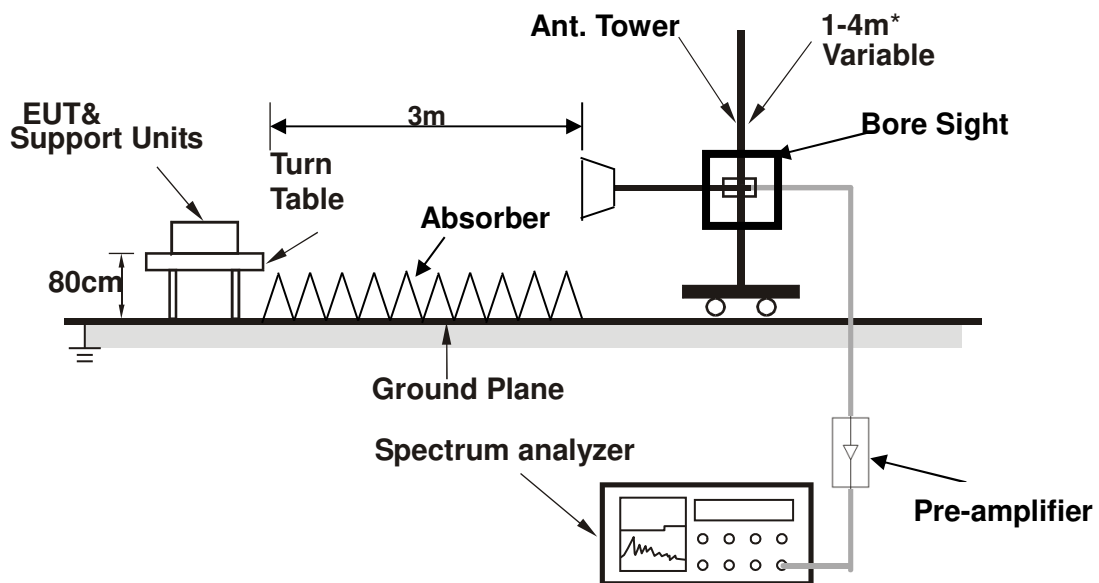
No deviation

### 3.2.5 TEST SETUP

<Frequency Range below 1GHz>



<Frequency Range above 1GHz>



\* :depends on the EUT height and the antenna 3dB beamwidth both, refer to section 7.3 of CISPR 16-2-3.

### 3.2.6 EUT OPERATING CONDITIONS

Same as item 3.1.6

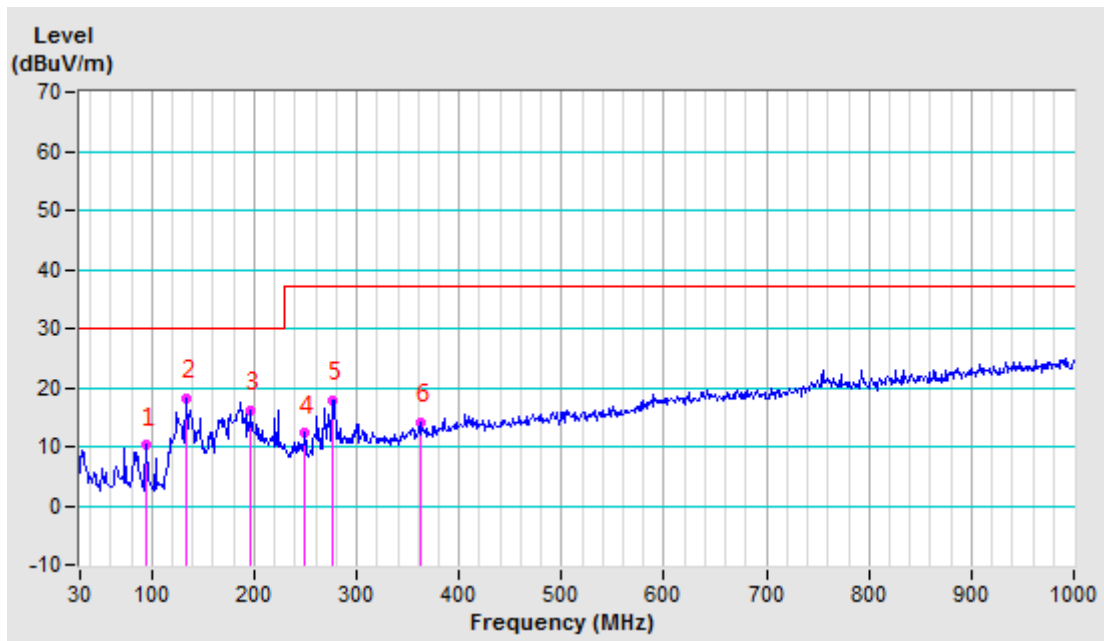


### 3.2.7 TEST RESULTS

<b>TEST MODE</b>	See section 2.2	<b>FREQUENCY RANGE</b>	30-1000 MHz
<b>TEST VOLTAGE</b>	See section 2.2	<b>DETECTOR FUNCTION &amp; BANDWIDTH</b>	Quasi-Peak, 120kHz
<b>ENVIRONMENTAL CONDITIONS</b>	17 deg. C, 64% RH	<b>TESTED BY:</b> Kamiko	

ANTENNA POLARITY & TEST DISTANCE: HORIZONTAL AT 10 M								
No.	Freq. (MHz)	Correction Factor (dB/m)	Raw Value (dBuV)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (cm)	Table Angle (Degree)
1	94.9900	-28.01	38.19	10.18	30.00	-19.82	200	23
2	133.7900	-22.97	41.26	18.29	30.00	-11.71	200	130
3	196.2337	-23.62	39.65	16.03	30.00	-13.97	400	167
4	249.9475	-21.25	33.49	12.24	37.00	-24.76	200	65
5	276.3800	-20.21	37.96	17.75	37.00	-19.25	200	114
6	361.7400	-18.07	32.21	14.14	37.00	-22.86	200	265

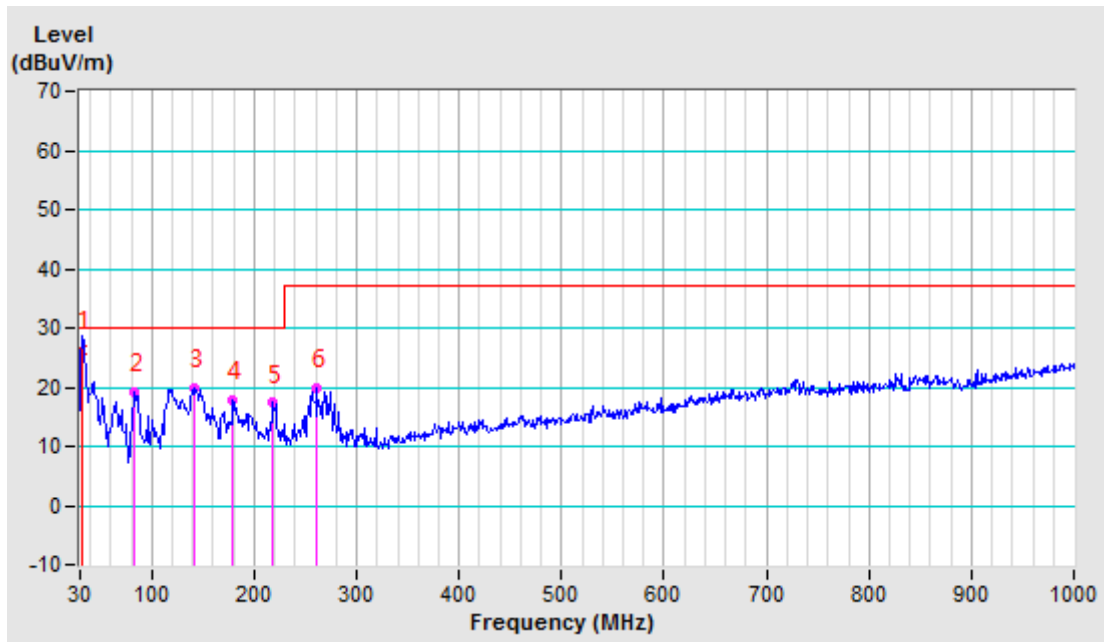
- REMARK:**
1. Peak detector quick scan is showed on the graph and final quasi-peak detector data is measured corresponding to relevant limit and recorded in the data table.
  2. Negative sign (-) in the margin column signify levels below the limit.
  3. Frequency range scanned: 30MHz to 1000MHz.
  4. Only emissions significantly above equipment noise floor are reported



<b>TEST MODE</b>	See section 2.2	<b>FREQUENCY RANGE</b>	30-1000 MHz
<b>TEST VOLTAGE</b>	See section 2.2	<b>DETECTOR FUNCTION &amp; BANDWIDTH</b>	Quasi-Peak, 120kHz
<b>ENVIRONMENTAL CONDITIONS</b>	17 deg. C, 64% RH	<b>TESTED BY:</b> Kamiko	

<b>ANTENNA POLARITY &amp; TEST DISTANCE: VERTICAL AT10 M</b>								
No.	Freq. (MHz)	Correction Factor (dB/m)	Raw Value (dBuV)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (cm)	Table Angle (Degree)
1	32.1700	-23.31	49.71	26.40	30.00	-3.60	100	214
2	83.6437	-26.15	45.40	19.25	30.00	-10.75	100	124
3	142.0891	-21.26	41.01	19.75	30.00	-10.25	100	221
4	179.4360	-22.92	40.80	17.88	30.00	-12.12	100	37
5	218.4804	-23.16	40.47	17.31	30.00	-12.69	300	20
6	260.6290	-21.41	41.25	19.84	37.00	-17.16	300	20

- REMARK:**
1. Peak detector quick scan is showed on the graph and final quasi-peak detector data is measured corresponding to relevant limit and recorded in the data table.
  2. Negative sign (-) in the margin column signify levels below the limit.
  3. Frequency range scanned: 30MHz to 1000MHz.
  4. Only emissions significantly above equipment noise floor are reported







### 3.3 HARMONICS CURRENT MEASUREMENT

#### 3.3.1 LIMITS OF HARMONICS CURRENT MEASUREMENT

TEST STANDARD: EN 61000-3-2 and EN 61000-3-12

DESCRIPTION & MANUFACTURER	MANUFACTURER	MODEL NO.	SERIAL NO.	CALIBRATED DATE	CALIBRATED UNTIL
PRECISION POWER ANALYZER	YOKOGAWA	WT3000	91M210852	Sep. 11,19	Sep. 11,20
Test Software	YOKOGAWA	IEC61000	N/A	N/A	N/A
REFERENCE IMPEDANCE NETWORK	Voltech	EUR	3018	Sep. 11,19	Sep. 11,20

- NOTE:** 1. The test was performed in PV Room.  
2. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to CEPREI/CHINA and NIM/CHINA.

#### 3.3.2 CURRENT EMISSION LIMITS FOR EQUIPMENT OTHER THAN BALANCED THREE-PHASE EQUIPMENT

Minimal $R_{sce}$	Admissible individual harmonic current $I_n/I_1$ <sup>a</sup> %						Admissible harmonic current distortion factors %	
	$I_3$	$I_5$	$I_7$	$I_9$	$I_{11}$	$I_{13}$	<i>THD</i>	<i>PWHD</i>
33	21,6	10,7	7,2	3,8	3,1	2	23	23
66	24	13	8	5	4	3	26	26
120	27	15	10	6	5	4	30	30
250	35	20	13	9	8	6	40	40
≥ 350	41	24	15	12	10	8	47	47

The relative values of even harmonics up to order 12 shall not exceed  $16/n$  %. Even harmonics above order 12 are taken into account in *THD* and *PWHD* in the same way as odd order harmonics.

NOTE Linear interpolation between successive  $R_{sce}$  values is permitted. See also Annex B.

<sup>a</sup>  $I_1$  = reference fundamental current;  $I_n$  = harmonic current component.



### 3.3.3 CURRENT EMISSION LIMITS FOR BALANCED THREE-PHASE EQUIPMENT

Minimal $R_{s_{ce}}$	Admissible individual harmonic current $I_n/I_1^a$ %				Admissible harmonic current distortion factors %	
	$I_5$	$I_7$	$I_{11}$	$I_{13}$	<i>THD</i>	<i>PWHD</i>
33	10,7	7,2	3,1	2	13	22
66	14	9	5	3	16	25
120	19	12	7	4	22	28
250	31	20	12	7	37	38
$\geq 350$	40	25	15	10	48	46

The relative values of even harmonics up to order 12 shall not exceed  $16/n$  %. Even harmonics above order 12 are taken into account in *THD* and *PWHD* in the same way as odd order harmonics.

NOTE Linear interpolation between successive  $R_{s_{ce}}$  values is permitted. See also Annex B.

<sup>a</sup>  $I_1$  = reference fundamental current;  $I_n$  = harmonic current component.

### 3.3.4 CURRENT EMISSION LIMITS FOR BALANCED THREE-PHASE EQUIPMENT UNDER SPECIFIED CONDITIONS

Minimal $R_{s_{ce}}$	Admissible individual harmonic current $I_n/I_1^a$ %				Admissible harmonic current distortion factors %	
	$I_5$	$I_7$	$I_{11}$	$I_{13}$	<i>THD</i>	<i>PWHD</i>
33	10,7	7,2	3,1	2	13	22
$\geq 120$	40	25	15	10	48	46

The relative values of even harmonics up to order 12 shall not exceed  $16/n$  %. Even harmonics above order 12 are taken into account in *THD* and *PWHD* in the same way as odd order harmonics.

NOTE Linear interpolation between successive  $R_{s_{ce}}$  values is permitted. See also Annex B.

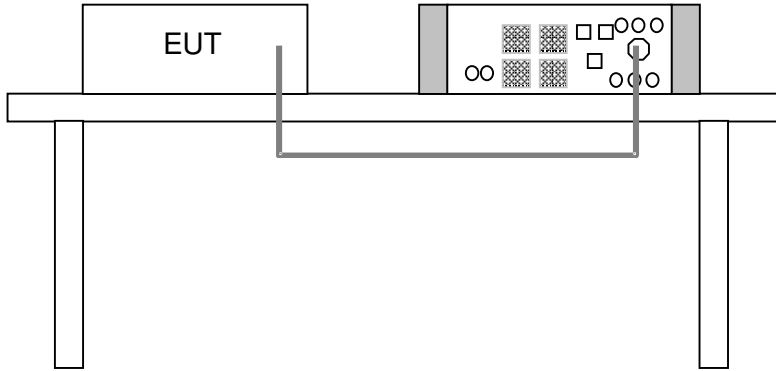
<sup>a</sup>  $I_1$  = reference fundamental current;  $I_n$  = harmonic current component.



### 3.3.5 DEVIATION FROM TEST STANDARD

No deviation

### 3.3.6 TEST SETUP



### 3.3.7 EUT OPERATING CONDITIONS

Same as item 3.1.6



### 3.3.8 TEST RESULTS

#### \*\*\*\*\* appliances (Average)

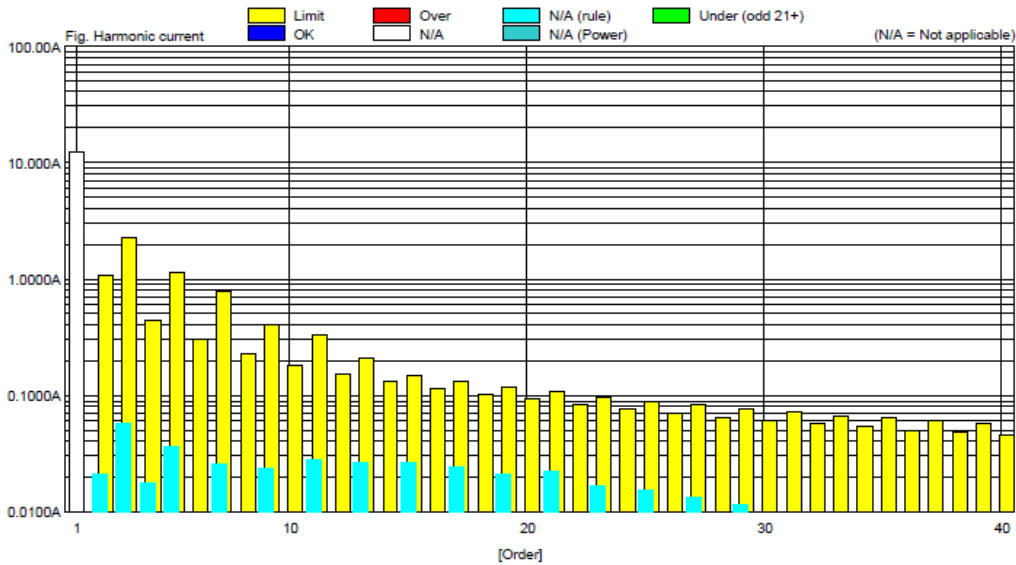
Print Date : Tue May 19 16:41:33 2020  
 MeasureDate : Tue May 19 16:41:03 2020  
 Comment : Experimental model Pattern A

Regulation : IEC61000-3-2 Ed3.0 am2  
 IEC61000-4-7 Ed2.0 A1  
 Class : CLASS A  
 MeasureTime : 149.80sec  
 Model : YOKOGAWA WT3000  
 Rating Voltage : 230.00 V  
 Wiring : single-phase 2-wire  
 Element : 1  
 Range : 300V/100.0A  
 Current(rms) : 12.3237 A  
 Voltage(rms) : 230.53 V  
 Frequency : 50.000 Hz  
 Power Factor : 0.9997  
 POHC Limit : 0.2514 A  
 POHC Max : 0.0408 A  
 THC : 0.1099 A

PASS

Set Fundamental I : -----  
 Set Power Factor : -----  
 Set P : -----  
 Sigma W Max : 2857.400 W  
 Sigma PF : 0.9997  
 Distortion factor(V) : 0.03 %  
 V THDS : 0.03 %  
 V THDG : 0.03 %  
 Distortion factor(A) : 0.81 %  
 A THDS : 0.85 %  
 A THDG : 0.89 %  
 P THD : 0.00 %  
 Power Limit : 75 W

Order	Measure[A]	Limit[A]	Margin[%]	Order	Measure[A]	Limit[A]	Margin[%]
1	12.3233			2	0.0215	1.0800	98.0
3	0.0583	2.3000	97.5	4	0.0177	0.4300	95.9
5	0.0364	1.1400	96.8	6	0.0099	0.3000	96.7
7	0.0255	0.7700	96.7	8	0.0092	0.2300	96.0
9	0.0241	0.4000	94.0	10	0.0071	0.1840	96.1
11	0.0280	0.3300	91.5	12	0.0069	0.1533	95.5
13	0.0267	0.2100	87.3	14	0.0052	0.1314	96.1
15	0.0261	0.1500	82.6	16	0.0047	0.1150	95.9
17	0.0249	0.1324	81.2	18	0.0042	0.1022	95.9
19	0.0216	0.1184	81.7	20	0.0048	0.0920	94.8
21	0.0218	0.1071	79.7	22	0.0034	0.0836	95.9
23	0.0164	0.0978	83.2	24	0.0033	0.0767	95.7
25	0.0154	0.0900	82.9	26	0.0032	0.0708	95.5
27	0.0133	0.0833	84.0	28	0.0035	0.0657	94.6
29	0.0117	0.0776	85.0	30	0.0028	0.0613	95.5
31	0.0099	0.0726	86.4	32	0.0026	0.0575	95.4
33	0.0080	0.0682	88.3	34	0.0026	0.0541	95.1
35	0.0077	0.0643	88.0	36	0.0026	0.0511	94.9
37	0.0071	0.0608	88.4	38	0.0026	0.0484	94.6
39	0.0065	0.0577	88.7	40	0.0026	0.0460	94.4





Test Report No.: CE200423N070

\*\*\*\*\* appliances (Maximum)

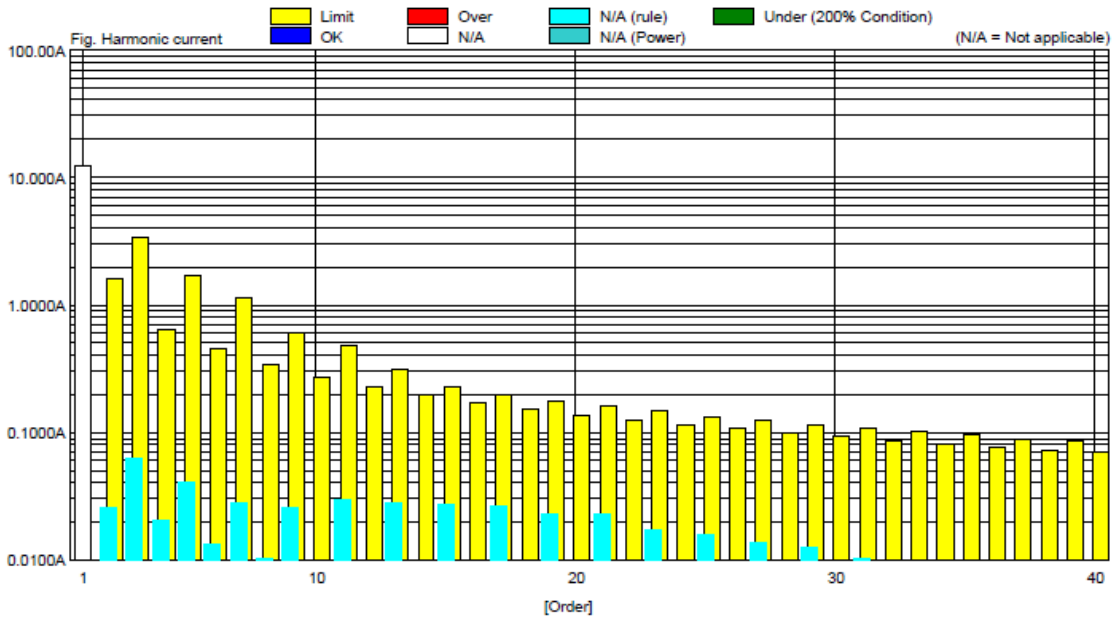
Print Date : Tue May 19 16:41:34 2020  
 MeasureDate : Tue May 19 16:41:03 2020  
 Comment : Experimental model Pattern A

Regulation : IEC61000-3-2 Ed3.0 am2  
 IEC61000-4-7 Ed2.0 A1  
 Class : CLASS A  
 MeasureTime : 149.80sec  
 Model : YOKOGAWA WT3000  
 Rating Voltage : 230.00 V  
 Wiring : single-phase 2-wire  
 Element : 1  
 Range : 300V/100.0A  
 Current(rms) : 12.3991 A  
 Voltage(rms) : 230.53 V  
 Frequency : 50.006 Hz  
 Power Factor : 0.9997  
 Beyond Limit Time : 14.9800 s  
 Beyond Total Time : 0.0000 s  
 THC : 0.1135 A

PASS

Set Fundamental I : -----  
 Set Power Factor : -----  
 Set P : -----  
 Sigma W Max : 2857.400 W  
 Sigma PF : 0.9997  
 Distortion factor(V) : 0.03 %  
 V THDS : 0.03 %  
 V THDG : 0.03 %  
 Distortion factor(A) : 0.87 %  
 A THDS : 0.92 %  
 A THDG : 0.98 %  
 P THD : 0.00 %  
 Power Limit : 75 W

Order	Measure[A]	Limit[A]	Margin[%]	Order	Measure[A]	Limit[A]	Margin[%]
1	12.3986			2	0.0251	1.6200	98.5
3	0.0618	3.4500	98.2	4	0.0208	0.6450	96.8
5	0.0409	1.7100	97.6	6	0.0134	0.4500	97.0
7	0.0282	1.1550	97.6	8	0.0105	0.3450	97.0
9	0.0251	0.6000	95.8	10	0.0089	0.2760	96.8
11	0.0298	0.4950	94.0	12	0.0088	0.2300	96.2
13	0.0282	0.3150	91.0	14	0.0067	0.1971	96.6
15	0.0273	0.2250	87.9	16	0.0058	0.1725	96.6
17	0.0261	0.1985	86.8	18	0.0051	0.1533	96.7
19	0.0227	0.1776	87.2	20	0.0058	0.1380	95.8
21	0.0229	0.1607	85.8	22	0.0041	0.1255	96.7
23	0.0172	0.1467	88.3	24	0.0040	0.1150	96.5
25	0.0161	0.1350	88.0	26	0.0038	0.1062	96.7
27	0.0140	0.1250	88.8	28	0.0042	0.0986	95.8
29	0.0124	0.1164	89.3	30	0.0033	0.0920	96.5
31	0.0103	0.1089	90.5	32	0.0031	0.0862	96.4
33	0.0085	0.1023	91.7	34	0.0030	0.0812	96.3
35	0.0083	0.0964	91.3	36	0.0031	0.0767	96.0
37	0.0074	0.0912	91.9	38	0.0030	0.0726	95.9
39	0.0069	0.0865	92.0	40	0.0029	0.0690	95.8





### 3.4 VOLTAGE FLUCTUATION AND FLICKS MEASUREMENT

#### 3.4.1 LIMITS OF VOLTAGE FLUCTUATION AND FLICKS MEASUREMENT

##### TEST STANDARD: EN 61000-3-3

TEST ITEM	LIMIT	NOTE
$P_{st}$	1.0	$P_{st}$ means short-term flicker indicator.
$P_{lt}$	0.65	$P_{lt}$ means long-term flicker indicator.
$T_{d(t)}$ (ms)	500	$T_{d(t)}$ means maximum time that $d(t)$ exceeds 3.3%.
$d_{max}$ (%)	4	$d_{max}$ means maximum relative voltage change.
$dc$ (%)	3.3	$dc$ means relative steady-state voltage change

##### TEST STANDARD: EN 61000-3-11

The test conditions specified in Annex A of EN 61000-3-3 shall be applicable to equipment rated  $\leq 16A$

The test impedance  $Z_{test}$  may be lower than  $Z_{ref}$ , particularly for equipment having a rated input current  $>16 A$ . To find the optimal test impedance, two conditions shall be met.

- firstly, the voltage drop,  $\Delta U$ , caused by the equipment shall be within the range 3 % to 5 % of the test supply voltage;
- secondly, the ratio of inductive to resistive components of  $Z_{test}$  given by  $X_{test} / R_{test}$  shall be within the range 0,5 to 0,75 (i.e. similar to the ratio of the components of  $Z_{ref}$ ).

NOTE The 3 % to 5 % condition ensures that the relative current changes of the equipment in the real network situation will be nearly the same as those during the test.

The test shall be made with the test circuit specified in Figure 1, except that the impedance  $Z_{ref}$  is replaced with  $Z_{test}$ . Four values  $d_{c\ test}$ ,  $d_{max\ test}$ ,  $P_{st\ test}$  and  $P_{lt\ test}$  shall be measured. The definitions of  $d_c$ ,  $d_{max}$ ,  $P_{st}$ , and  $P_{lt}$  are given in IEC 61000-3-3.



### 3.4.2 TEST INSTRUMENTS

Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Next Cal.
PRECISION POWER ANALYZER	YOKOGAWA	WT3000	91M210852	Sep. 11,19	Sep. 11,20
Test Software	YOKOGAWA	IEC61000	N/A	N/A	N/A
REFERENCE IMPEDANCE NETWORK	Voltech	EUR	3018	Sep. 11,19	Sep. 11,20

- NOTE:** 1. The test was performed in PV Room.  
2. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to CEPREI/CHINA, GRGT/CHINA and NIM/CHINA.

### 3.4.3 TEST PROCEDURE

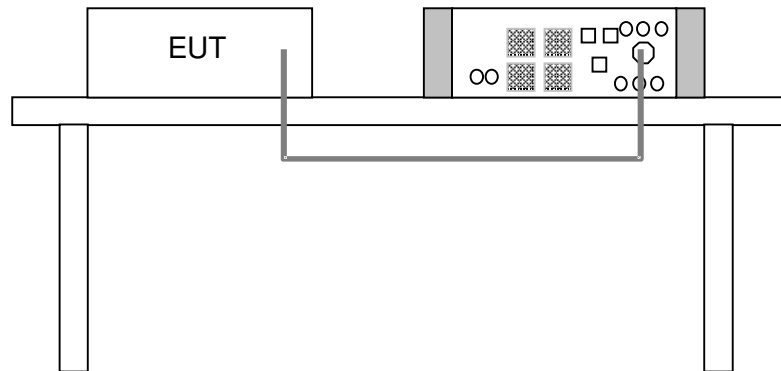
- a. The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the most unfavorable sequence of voltage changes under normal operating conditions.
- b. During the flick measurement, the measure time shall include that part of whole operation cycle in which the EUT produce the most unfavorable sequence of voltage changes. The observation period for short-term flicker indicator is 10 minutes and the observation period for long-term flicker indicator is 2 hours.



### 3.4.4 DEVIATION FROM TEST STANDARD

No deviation

### 3.4.5 TEST SETUP



### 3.4.6 EUT OPERATING CONDITIONS

Same as item 3.1.6





### 3.4.7 TEST RESULTS

Regulation : IEC61000-3-3 Ed2.0  
 IEC61000-4-15 Ed1.1  
 Interval : 10Min0Sec  
 Model : YOKOGAWA WT3000  
 Wiring : single-phase 2wire  
 Voltage Range : 300.00V  
 Voltage U1 : 235.85V  
 Set Frequency : 50Hz  
 Frequency U1 : 50.002Hz  
 Element : 1  
 dmin : 0.10%

**PASS**

Element1 : Pass  
 dc (3.30%) : Pass  
 dmax (4.00%) : Pass  
 d(t) (500ms) : Pass  
 Pst (1.00) : Pass  
 PIt (0.65) : Pass

No.	dc[%]	dmax[%]	d(t)[ms]	Pst
1	0.07	0.14	0.00	0.14
2	0.06	0.14	0.00	0.14
3	0.07	0.14	0.00	0.14
4	0.06	0.13	0.00	0.14
5	0.06	0.14	0.00	0.14
6	0.07	0.14	0.00	0.14
7	0.06	0.14	0.00	0.14
8	0.06	0.14	0.00	0.14
9	0.06	0.14	0.00	0.14
10	0.06	0.15	0.00	0.14
11	0.06	0.14	0.00	0.14
12	0.06	0.14	0.00	0.14
				PIt
				0.14



## 4 IMMUNITY TEST

### 4.1 GENERAL DESCRIPTION

#### 4.1.1 GENERAL DESCRIPTION OF EN 61000-6-2

Product Standard:	EN 61000-6-2:2005	
<b>Basic Standard, specification requirement, and Performance Criteria:</b>	IEC 61000-4-2	Electrostatic Discharge – ESD: 4kV Contact discharge, 8kV air discharge, Performance Criterion B
	IEC 61000-4-3	Radio-Frequency Electromagnetic Field Susceptibility Test – RS: 80-1000 MHz, 10V/m, 80% AM (1kHz), 1400-2000 MHz, 3V/m, 80% AM (1kHz) 2000-2700 MHz, 1V/m, 80% AM (1kHz) Performance Criterion A
	IEC 61000-4-4	Electrical Fast Transient/Burst - EFT AC Power line: 2kV, DC Power line: 2kV Signal line: 1kV Performance Criterion B
	IEC 61000-4-5	Surge Immunity Test: 1.2/50 us Open Circuit Voltage, 8 /20 us Short Circuit Current, AC Power Line: line to line 1 kV, line to earth 2kV DC Power Line: line to line 0.5kV line to earth 0.5kV Signal line: 1kV Performance Criterion B
	IEC 61000-4-6	Conducted Radio Frequency Disturbances Test – CS:0.15-80 MHz, 10Vrms, 80% AM, 1kHz, Performance Criterion A
	IEC 61000-4-8	Power Frequency Magnetic Field Test, 50/60 Hz, 30A/m, Performance Criterion A



### 4.1.2 PERFORMANCE CRITERIA

According to Clause 4 of EN 61000-6-2:2005 standard, the following describes the general performance criteria.

<b>CRITERION A</b>	The apparatus shall continue to operate as intended during and after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, either of these may be derived from the product description and documentation and what the user may reasonably expect from the apparatus if used as intended.
<b>CRITERION B</b>	The apparatus shall continue to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. The performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed. No change of actual operating state or stored data is allowed. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, either of these may be derived from the product description and documentation and what the user may reasonably expect from the apparatus if used as intended.
<b>CRITERION C</b>	Temporary loss of function is allowed, provided the function is self-recoverable or can be restored by the operation of the controls.

### 4.1.3 EUT OPERATING CONDITION

Same as item 3.1.6



## 4.2 ELECTROSTATIC DISCHARGE IMMUNITY TEST (ESD)

### 4.2.1 TEST SPECIFICATION

<b>Basic Standard:</b>	IEC 61000-4-2
<b>Discharge Impedance:</b>	330 ohm / 150 pF
<b>Discharge Voltage:</b>	Air Discharge: 8 kV (Direct) Contact Discharge: 4 kV (Indirect)
<b>Polarity:</b>	Positive & Negative
<b>Number of Discharge:</b>	20 times at each test point
<b>Discharge Mode:</b>	Single Discharge
<b>Discharge Period:</b>	1 second

### 4.2.2 TEST INSTRUMENTS

Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Next Cal.
ESD Generator	TESEQ	NSG 437	279	Mar. 06,20	Mar. 05,21
Test Software	TESEQ	V03.03	N/A	N/A	N/A
ESD Generator	EM TEST	Dito	V1211112265	Nov. 30,19	Nov. 29,20
Test Software	EM TEST	V 2.31	N/A	N/A	N/A

- NOTE:** 1. The test was performed in ESD Room.  
2. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to CEPREI/CHINA, GRGT/CHINA and NIM/CHINA.



### 4.2.3 TEST PROCEDURE

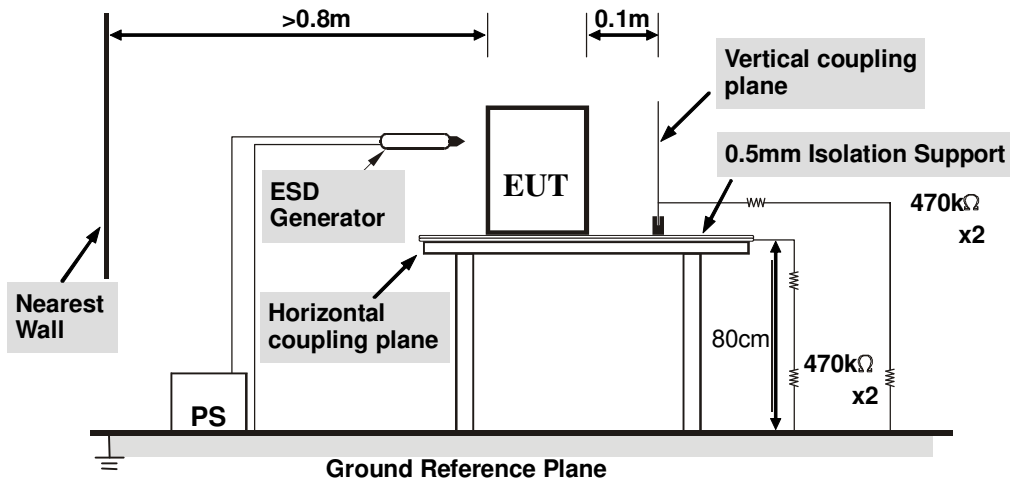
The basic test procedure was in accordance with IEC 61000-4-2:

- a. Electrostatic discharges were applied only to those points and surfaces of the EUT that are accessible to users during normal operation.
- b. The test was performed with at least ten single discharges on the pre-selected points in the most sensitive polarity.
- c. The time interval between two successive single discharges was at least 1 second.
- d. The discharge return cable of the generator shall be kept at a distance of at least 0.2 m from the EUT whilst the discharge is being applied and should not be held by the operator.
- e. Contact discharges were applied to the non-insulating coating, with the pointed tip of the generator penetrating the coating and contacting the conducting substrate.
- f. Air discharges were applied with the round discharge tip of the discharge electrode approaching the EUT as fast as possible (without causing mechanical damage) to touch the EUT. After each discharge, the ESD generator was removed from the EUT and re-triggered for a new single discharge. The test was repeated until all discharges were complete.
- g. At least ten single discharges (in the most sensitive polarity) were applied to the **Horizontal Coupling Plane** at points on each side of the EUT. The ESD generator was positioned horizontal at a distance of 0.1 meters from the EUT with the discharge electrode touching the **HCP**.
- h. At least ten single discharges (in the most sensitive polarity) were applied to the center of one vertical edge of the **Vertical Coupling Plane** in sufficiently different positions that the four faces of the EUT were completely illuminated. The **VCP** (dimensions 0.5m x 0.5m) was placed vertically to and 0.1 meters from the EUT.

### 4.2.4 DEVIATION FROM TEST STANDARD

No Deviation

## 4.2.5 TEST SETUP



### NOTE:

#### TABLE-TOP EQUIPMENT

The configuration consisted of a wooden table 0.8 meters high standing on the **Ground Reference Plane**. The **GRP** consisted of a sheet of aluminum at least 0.25mm thick, and 2.5 meters square connected to the protective grounding system. A **Horizontal Coupling Plane** (1.6m x 0.8m) was placed on the table and attached to the **GRP** by means of a cable with 940kΩ total impedance. The equipment under test, was installed in a representative system as described in section 7 of IEC 61000-4-2, and its cables were placed on the **HCP** and isolated by an insulating support of 0.5mm thickness. A distance of 0.8-meter minimum was provided between the EUT and the walls of the laboratory and any other metallic structure.

#### FLOOR-STANDING EQUIPMENT

The equipment under test was installed in a representative system as described in section 7 of IEC 61000-4-2, and its cables were isolated from the Ground Reference Plane by an insulating support of 0.1-meter thickness. The GRP consisted of a sheet of aluminum that is at least 0.25mm thick, and 2.5 meters square connected to the protective grounding system and extended at least 0.5 meters from the EUT on all sides.



### 4.2.6 TEST RESULTS

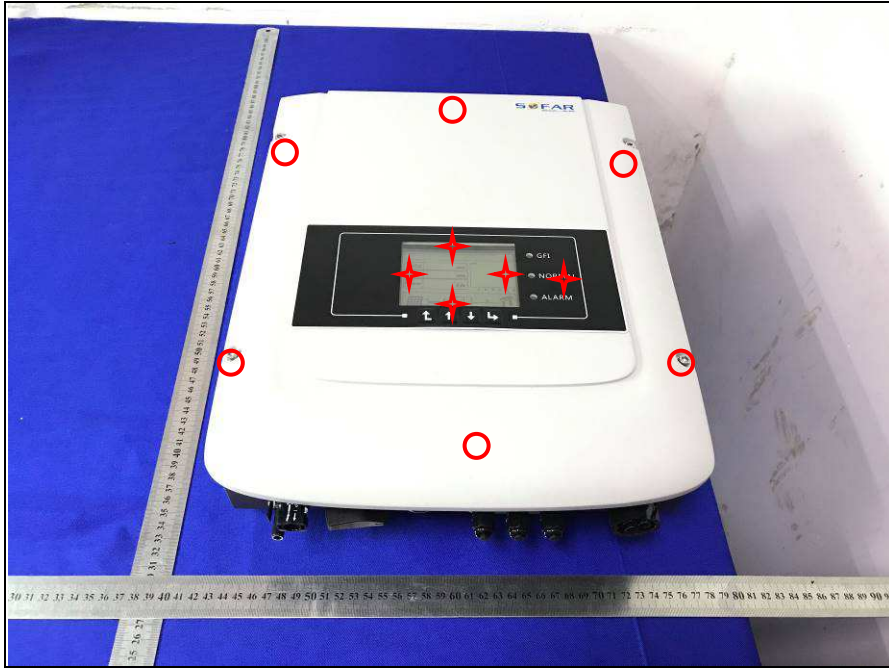
<b>TEST MODE</b>	See section 2.2	<b>TEST VOLTAGE</b>	See section 2.2
<b>ENVIRONMENTAL CONDITIONS</b>	24deg. C, 54% RH 101.3kPa	<b>TESTED BY:</b> Dragon	

Direct Discharge Application				
Test Level (kV)	Polarity	Test Point	Test Result of Contact Discharge	Test Result of Air Discharge
4	+/-	All Metal Part	A	N/A
8	+/-	All Non-metal Part	N/A	A

Indirect Discharge Application				
Discharge Level (kV)	Polarity	Test Point	Test Result of HCP	Test Result of VCP
4	+/-	HCP	A	N/A
4	+/-	VCP	N/A	A

**NOTE:** A: There was no change compared with initial operation during the test.

ESD TEST POINT  
( ○ - Direct Contact Discharge; ✦ -Air Discharge)







### 4.3 RADIATED, RADIO-FREQUENCY, ELECTROMAGNETIC FIELD IMMUNITY TEST (RS)

#### 4.3.1 TEST SPECIFICATION

<b>Basic Standard:</b>	IEC 61000-4-3
<b>Frequency Range:</b>	80-1000MHz, 1400-2000MHz, 2000-2700MHz
<b>Field Strength:</b>	10V/m, 3V/m, 1V/m
<b>Modulation:</b>	1kHz Sine Wave, 80%, AM Modulation
<b>Frequency Step:</b>	1 % of fundamental
<b>Polarity of Antenna:</b>	Horizontal and Vertical
<b>Antenna Height:</b>	1.5m
<b>Dwell Time:</b>	at least 3 seconds

#### 4.3.2 TEST INSTRUMENTS

Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Next Cal.
Signal Generator	Agilent	N5181A	MY50142530	Sep. 12,19	Sep. 11,20
Antenna Log-Periodic	AR	ATR80M6G	0337307	N/A	N/A
Antenna Log-Periodic	AR	ATS700M11G	0336821	N/A	N/A
Switch Controller	AR	SC1000	0337343	N/A	N/A
RF Power Meter	Boonton	4242	13984	Sep. 12,19	Sep. 11,20
Power Sensor	Boonton	51011EMC	35716	Sep. 12,19	Sep. 11,20
Power Sensor	Boonton	51011EMC	35715	Sep. 12,19	Sep. 11,20
E-Field probe	Narda	NBM-520	2403/01B	Dec. 24,19	Dec. 23,20
Power Amplifier	TESEQ	CBA 1G-150	T44029	N/A	N/A
Power Amplifier	TESEQ	CBA 3G-100	T44030	N/A	N/A
Power Amplifier	TESEQ	CBA 6G-050	1041204	N/A	N/A
Dual Directional Coupler	TESEQ	C5982	95208	Sep. 21,19	Sep. 20,20
Dual Directional Coupler	TESEQ	C6187	95175	Sep. 21,19	Sep. 20,20
Dual Directional Coupler	TESEQ	CPH-274F	M251304-01	Sep. 21,19	Sep. 20,20
Audio analyzer	Rohde&Schwarz	UPV	101397	Sep. 18,19	Sep. 17,20
Conditioning Amplifier	B&K	2690A0S2	2437856	Oct. 18,19	Oct. 17,20
EAR SIMULATOR	B&K	4192	2764719	Jun. 01,19	May 30,20
Test Software	Tonscend	TS+	2.0.1.8	N/A	N/A
Test Software	ADT	BVADT_RS_V 7.6.4-DG	N/A	N/A	N/A

**NOTE:** 1. The test was performed in RS chamber.  
 2. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to CEPREI/CHINA, GRGT/CHINA and NIM/CHINA.



### 4.3.3 TEST PROCEDURE

The test procedure was in accordance with IEC 61000-4-3

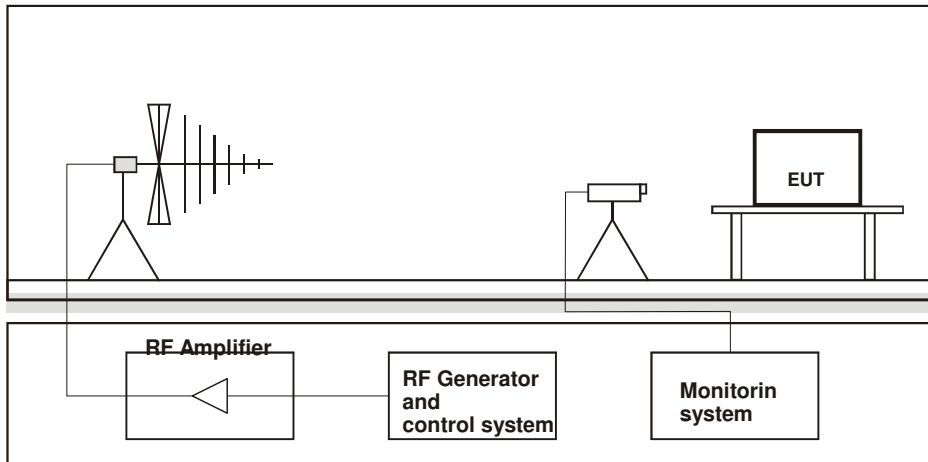
- a. The testing was performed in a fully-anechoic chamber.
- b. The frequency range is swept from 80 MHz to 1000 MHz, 1400MHz to 2000MHz, 2000MHz to 2700MHz with the signal 80% amplitude modulated with a 1kHz sine wave.
- c. The dwell time at each frequency shall not be less than the time necessary for the EUT to be exercised and to respond, but shall in no case be less than 0,5s.
- d. The field strength levels were 10V/m, 3V/m, 1V/m.
- e. The test was performed with the EUT exposed to both vertically and horizontally polarized fields on each of the four sides.

### 4.3.4 DEVIATION FROM TEST STANDARD

No Deviation



### 4.3.5 TEST SETUP



**NOTE:**

TABLETOP EQUIPMENT

The EUT installed in a representative system as described in section 7 of IEC 61000-4-3 was placed on a non-conductive table 0.8 meters in height. The system under test was connected to the power and signal wire according to relevant installation instructions.

FLOOR STANDING EQUIPMENT

The EUT installed in a representative system as described in section 7 of IEC 61000-4-3 was placed on a non-conductive wood support 0.1 meters in height. The system under test was connected to the power and signal wire according to relevant installation instructions.



### 4.3.6 TEST RESULTS

<b>TEST MODE</b>	See section 2.2	<b>TEST VOLTAGE</b>	See section 2.2
<b>ENVIRONMENTAL CONDITIONS</b>	23deg. C, 53% RH	<b>TESTED BY:</b> Andy	

Field Strength (V/m)	Test Frequency Note#1 (MHz)	Polarization of antenna (Horizontal / Vertical)	Test Distance (m)	Test Result	Remark
10	80 - 1000	H&V	3	A	N/A
3	1400 - 2000	H&V	3	A	N/A
1	2000 - 2700	H&V	3	A	N/A

Note#1:

Tested Israel SII Frequencies 89,100,107,144,163,196,244,315,434,460,600,825,845,880 MHz

**NOTE:** A: There was no change compared with initial operation during the test.



## 4.4 ELECTRICAL FAST TRANSIENT/BURST IMMUNITY TEST (EFT)

### 4.4.1 TEST SPECIFICATION

<b>Basic Standard:</b>	IEC 61000-4-4
<b>Test Voltage:</b>	Power Line: 2kV
<b>Polarity:</b>	Positive & Negative
<b>Impulse Frequency:</b>	5 kHz
<b>Impulse Waveshape :</b>	5/50 ns
<b>Burst Duration:</b>	15 ms
<b>Burst Period:</b>	300 ms
<b>Test Duration:</b>	1 min.

### 4.4.2 TEST INSTRUMENTS

Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Next Cal.
EFT Module	TESEQ	NSG 3060 Mainframe	1404	Mar. 25,20	Mar. 24,21
Automated 3- Phase Coupling/ Decoupling Network	TESEQ	CDN 3063	2131	Mar. 25,20	Mar. 24,21
EFT Coupling Clamp	HAEFELY	IP4A	150407	Mar. 18,20	Mar. 17,21
Test Software	TESEQ	CDM 3061_0002.30	1361	N/A	N/A
Test Software	TESEQ	HVM 3060_0002.30	293	N/A	N/A

- NOTE:** 1. The test was performed in EMS Room.  
 2. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to CEPREI/CHINA, GRGT/CHINA and NIM/CHINA.

### 4.4.3 TEST PROCEDURE

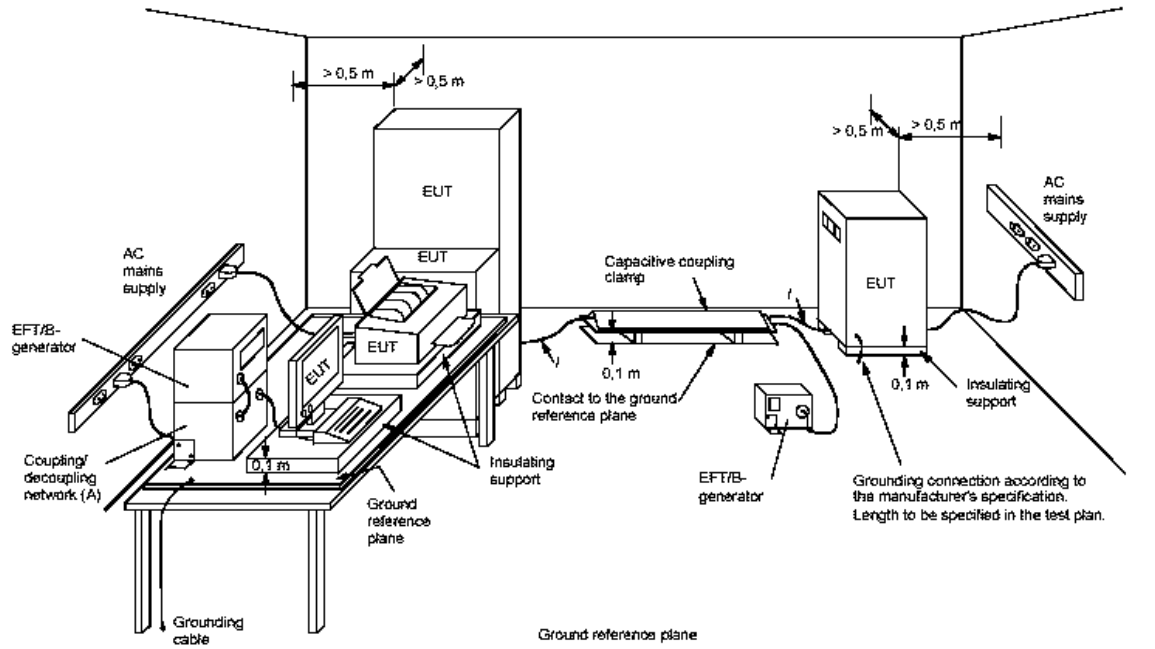
- a. Both positive and negative polarity discharges were applied.
- b. The length of the “hot wire” from the coaxial output of the EFT generator to the terminals on the EUT should not exceed 0.5 meter ± 0.05 meter.
- c. The duration time of each test sequential was 1 minute.
- d. The transient/burst waveform was in accordance with IEC 61000-4-4, 5/50ns.

### 4.4.4 DEVIATION FROM TEST STANDARD

No deviation.



### 4.4.5 TEST SETUP



**NOTE:**

**TABLETOP EQUIPMENT**

The configuration consisted of a wooden table standing on the Ground Reference Plane and should be located 0.1m +/- 0.01m above the Ground Reference Plane.

The GRP consisted of a sheet of aluminum (at least 0.25mm thick and 2.5m square) connected to the protective grounding system. A minimum distance of 0.5m was provided between the EUT and the walls of the laboratory or any other metallic structure.

**FLOOR STANDING EQUIPMENT**

The EUT installed in a representative system as described in section 7 of IEC 61000-4-4 and its cables, were isolated from the Ground Reference Plane by an insulating support that is 0.1-meter thick. The GRP consisted of a sheet of aluminum (at least 0.25mm thick and 2.5m square) connected to the protective grounding system.



### 4.4.6 TEST RESULTS

<b>TEST MODE</b>	See section 2.2	<b>TEST VOLTAGE</b>	See section 2.2
<b>ENVIRONMENTAL CONDITIONS</b>	21.9 deg. C, 53.5% RH	<b>TESTED BY:</b> Wang	

Pulse Voltage Pulse Polarity	2.0 kV		kV		kV	
	+	-	+	-	+	-
L	A	A	/	/	/	/
N	A	A	/	/	/	/
PE	A	A	/	/	/	/
L+N	A	A	/	/	/	/
L+PE	A	A	/	/	/	/
N+PE	A	A	/	/	/	/
L+N+PE	A	A	/	/	/	/
DC Line	A	A	/	/	/	/

**NOTE:** A: There was no change compared with initial operation during the test.



## 4.5 SURGE IMMUNITY TEST

### 4.5.1 TEST SPECIFICATION

<b>Basic Standard:</b>	IEC 61000-4-5
<b>Wave-Shape:</b>	Combination Wave 1.2/50 us Open Circuit Voltage 8 /20 us Short Circuit Current
<b>Test Voltage:</b>	AC Power Line : Line to Line:1kV Line to PE:2kV
<b>Surge Input/Output:</b>	L-N&L-PE&N-PE
<b>Generator Source Impedance:</b>	2ohm between networks 12 ohm between network and ground
<b>Polarity:</b>	Positive/Negative
<b>Phase Angle:</b>	0° /90°/180°/270°
<b>Pulse Repetition Rate:</b>	1 time / 60 sec.
<b>Number of Tests:</b>	5 positive and 5 negative at selected points

### 4.5.2 TEST INSTRUMENTS

Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Next Cal.
Telecom Surge Module	TESEQ	NSG 3060 Mainframe	1404	Mar. 25,20	Mar. 24,21
Automated 3- Phase Coupling/ Decoupling Network	TESEQ	CDN 3063	2131	Mar. 25,20	Mar. 24,21
CDN	TESEQ	CDN HSS-2	34275	Mar. 25,20	Mar. 24,21
CDN	TESEQ	CDN 118	30741	Mar. 25,20	Mar. 24,21
Test Software	TESEQ	CDM 3061_0002.30	1361	N/A	N/A
Test Software	TESEQ	HVM 3060_0002.30	293	N/A	N/A

- NOTE:** 1. The test was performed in EMS Room.  
2. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to CEPREI/CHINA, GRGT/CHINA and NIM/CHINA.





### 4.5.3 TEST PROCEDURE

- a. For EUT power supply:

The surge is to be applied to the EUT power supply terminals via the capacitive coupling network. Decoupling networks are required in order to avoid possible adverse effects on equipment not under test that may be powered by the same lines, and to provide sufficient decoupling impedance to the surge wave. The power cord between the EUT and the coupling/decoupling networks shall be 2 meters in length (or shorter).

- b. For test applied to unshielded unsymmetrically operated interconnection lines of EUT:

The surge is applied to the lines via the capacitive coupling. The coupling / decoupling networks shall not influence the specified functional conditions of the EUT. The interconnection line between the EUT and the coupling/decoupling networks shall be 2 meters in length (or shorter).

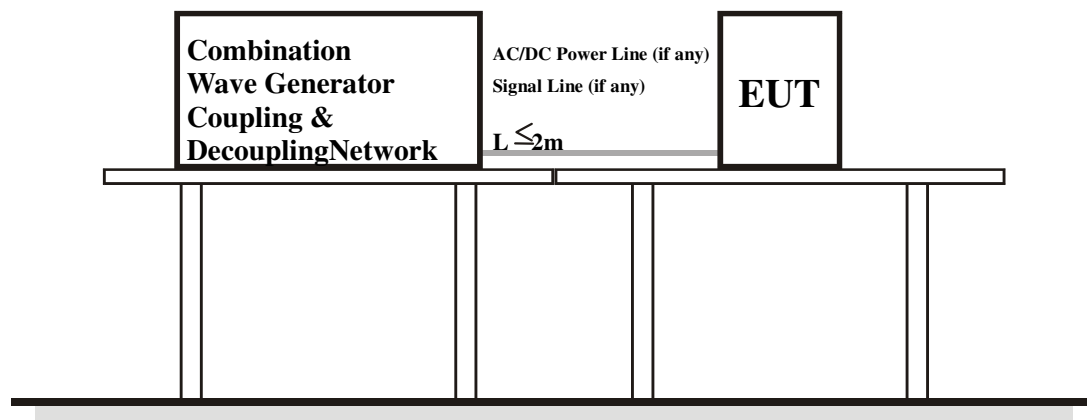
- c. For test applied to unshielded symmetrically operated interconnection / telecommunication lines of EUT:

The surge is applied to the lines via gas arrestors coupling. Test levels below the ignition point of the coupling arrestor cannot be specified. The interconnection line between the EUT and the coupling/decoupling networks shall be 2 meters in length (or shorter).

### 4.5.4 DEVIATION FROM TEST STANDARD

No deviation.

### 4.5.5 TEST SETUP





### 4.5.6 TEST RESULTS

<b>TEST MODE</b>	See section 2.2	<b>TEST VOLTAGE</b>	See section 2.2
<b>ENVIRONMENTAL CONDITIONS</b>	23.9eg. C, 52.7% RH	<b>TESTED BY:</b> Wang	

**AC/DC Power port:**

\Phase angle \ Test result		0°	90°	180°	270°	DC Power Port
\Voltage (kV)	\ Test point \ Polarity					
1	L-N	+	B	B	B	N/A
		-	B	B	B	N/A
2	L-PE	+	B	B	B	N/A
		-	B	B	B	N/A
2	N-PE	+	B	B	B	N/A
		-	B	B	B	N/A

**Signal ports and telecommunication ports:**

Voltage (kV)	Test Point	Polarity	Test result	Voltage (kV)	Test Point	Polarity	Test result
/	/	+/-	/	/	/	+/-	/

**NOTE:** A: There was no change compared with initial operation during the test.  
 B: During test, EUT stopped grid, and could automatically return to normal after test.



## 4.6 IMMUNITY TO CONDUCTED DISTURBANCES INDUCED BY RF FIELDS (CS)

### 4.6.1 TEST SPECIFICATION

<b>Basic Standard:</b>	IEC 61000-4-6
<b>Frequency Range:</b>	0.15 MHz - 80 MHz
<b>Field Strength:</b>	10V <sub>r.m.s</sub>
<b>Modulation:</b>	1kHz Sine Wave, 80%, AM Modulation
<b>Frequency Step:</b>	1 % of fundamental
<b>Coupled Cable:</b>	Power Mains & DC Power Line
<b>Coupling Device:</b>	CDN-M532, Clamp

### 4.6.2 TEST INSTRUMENTS

Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Next Cal.
Signal Generator	Rohde&Schwarz	SMB 100A	102382	Mar. 18,20	Mar. 17,21
CDN	Luthi	L-801M2/M3	2015	Sep. 18,19	Sep. 17,20
CDN(AUX)	TESEQ	CDN M016	27452	Sep. 18,19	Sep. 17,20
CDN	TESEQ	T200A	26944	Mar. 18,20	Mar. 17,21
CDN	TESEQ	ST08A	32256	Mar. 18,20	Mar. 17,21
CDN	TESEQ	T800	28623	May 14, 20	May 13, 21
CDN	FCC	FCC-801-T8-S RJ45	160168	Sep. 18,19	Sep. 17,20
CDN	TESEQ	CDN M532	37300	Sep. 18,19	Sep. 17,20
6dB 150Watt Attenuator	Bird	150-A-FFN-06	1507	Sep. 18,19	Sep. 17,20
Bulk Current Injection Probe	FCC	F-120-9A	160053	Sep. 18,19	Sep. 17,20
Power Amplifier	PRANA	DR 220	1512-1788	NA	NA
Electromagnetic Injection Clamp	Luthi	EM101	35640	Sep. 25,19	Sep. 24,20
Audio analyzer	Rohde&Schwarz	UPV	101397	Sep. 18,19	Sep. 17,20
Conditioning Amplifier	B&K	2690A0S2	2437856	Oct. 18,19	Oct. 17,20
EAR SIMULATOR	B&K	4192	2764719	Jun. 01,19	May 30,20
Test Software	Tonscend	TS+	2.0.1.7	N/A	N/A
Test Software	ADT	BVADT_CS_V 7.6.2	N/A	N/A	N/A

- NOTE:** 1. The test was performed in CS test room.  
 2. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to CEPREI/CHINA, GRGT/CHINA and NIM/CHINA.



### 4.6.3 TEST PROCEDURE

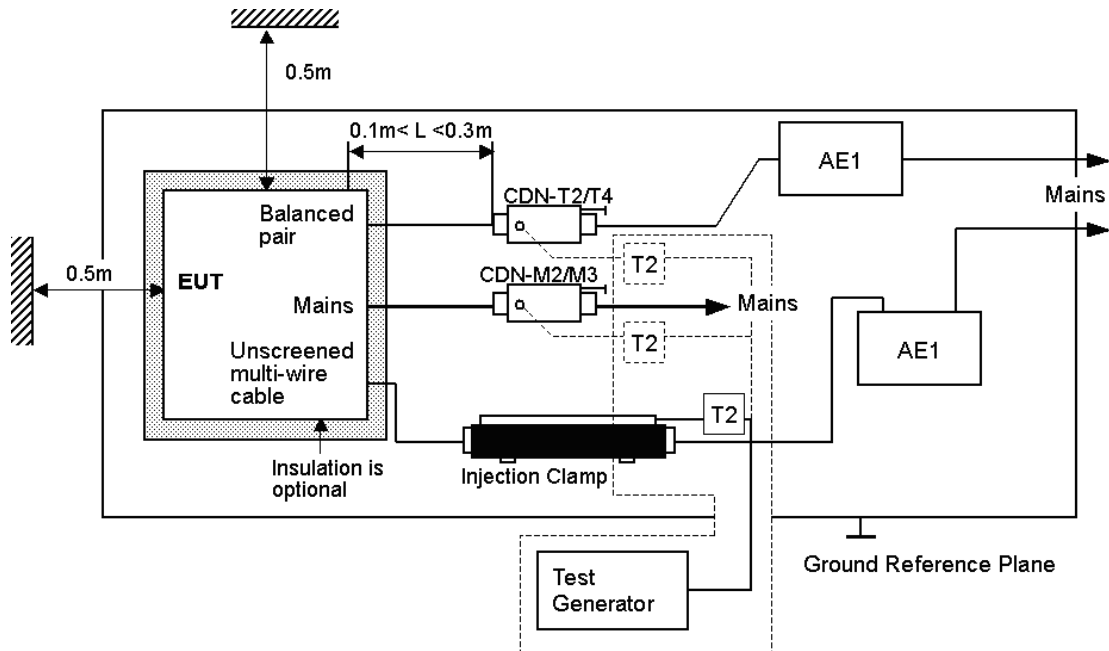
- a. The EUT shall be tested within its intended operating and climatic conditions.
- b. An artificial hand was placed on the hand-held accessory and connected to the ground reference plane.
- c. The test shall be performed with the test generator connected to each of the coupling and decoupling devices in turn, while the other non-excited RF input ports of the coupling devices are terminated by a 50-ohm load resistor.
- d. The frequency range is swept from 150 kHz to 80 MHz, using the signal level established during the setting process and with a disturbance signal of 80 % amplitude. The signal is modulated with a 1 kHz sine wave, pausing to adjust the RF signal level or the switch coupling devices as necessary. Where the frequency is swept incrementally, the step size shall not exceed 1 % of the preceding frequency value.
- e. The dwell time of the amplitude modulated carrier at each frequency shall not be less than the time necessary for the EUT to be exercised and to respond, but shall in no case be less than 0,5 s. The sensitive frequencies (e.g. clock frequencies) shall be analyzed separately.
- f. Attempts should be made to fully exercise the EUT during testing, and to fully interrogate all exercise modes selected for susceptibility.

### 4.6.4 DEVIATION FROM TEST STANDARD

No deviation.



### 4.6.5 TEST SETUP



NOTE: The EUT clearance from any metallic obstacles shall be at least 0.5m.  
All non-excited input ports of the CDNs shall be terminated by 50Ω loads.

**NOTE:**

FLOOR-STANDING EQUIPMENT

The equipment to be tested is placed on an insulating support of 0.1 meters height above a ground reference plane. All relevant cables shall be provided with the appropriate coupling and decoupling devices at a distance between 0.1 meters and 0.3 meters from the projected geometry of the EUT on the ground reference plane.



### 4.6.6 TEST RESULTS

<b>TEST MODE</b>	See section 2.2	<b>TEST VOLTAGE</b>	See section 2.2
<b>ENVIRONMENTAL CONDITIONS</b>	22deg. C, 54% RH	<b>TESTED BY:</b> Andy	

Voltage (V)	Test Frequency Note#1 (MHz)	Tested Line	Injection Method.	Test Result	Remark
10	0.15 – 80	AC Line	CDN-M532	A	N/A
10	0.15 – 80	DC Line	Clamp	A	N/A

Note#1: Tested Israel SII Frequencies 0.2,0.53,1,1.5,7.1,13.56,21,27.12,40.68,65,68 MHz

**NOTE:** A: There was no change compared with initial operation during the test.



## 4.7 POWER FREQUENCY MAGNETIC FIELD IMMUNITY TEST

### 4.7.1 TEST SPECIFICATION

<b>Basic Standard:</b>	IEC 61000-4-8
<b>Frequency Range:</b>	50/60Hz
<b>Field Strength:</b>	30A/m
<b>Observation Time:</b>	5 minute
<b>Inductance Coil:</b>	Rectangular type, 1mx1m

### 4.7.2 TEST INSTRUMENTS

Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Next Cal.
Magnetic Field Tester	HAEFELY	MAG100.1	150579	Sep. 18,19	Sep. 17,20
Test Software	N/A	N/A	N/A	N/A	N/A

**NOTE:** 1. The test was performed in Shielding Room 843.  
 2. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to CEPREI/CHINA, GRGT/CHINA and NIM/CHINA.

### 4.7.3 TEST PROCEDURE

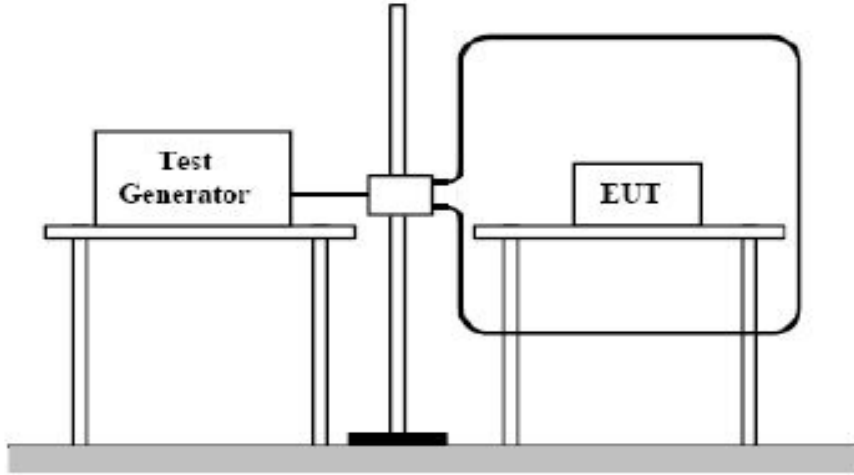
- The equipment is configured and connected to satisfy its functional requirements.
- The power supply, input and output circuits shall be connected to the sources of power supply, control and signal.
- The cables supplied or recommended by the equipment manufacturer shall be used. 1 meter of all cables used shall be exposed to the magnetic field.

### 4.7.4 DEVIATION FROM TEST STANDARD

No deviation.



## 4.7.5 TEST SETUP



### NOTE:

#### TABLETOP EQUIPMENT

The equipment shall be subjected to the test magnetic field by using the induction coil of standard dimension (1 m x 1 m). The induction coil shall then be rotated by 90 degrees in order to expose the EUT to the test field with different orientations.

#### FLOOR-STANDING EQUIPMENT

The equipment shall be subjected to the test magnetic field by using induction coils of suitable dimensions. The test shall be repeated by moving and shifting the induction coils, in order to test the whole volume of the EUT for each orthogonal direction. The test shall be repeated with the coil shifted to different positions along the side of the EUT, in steps corresponding to 50 % of the shortest side of the coil. The induction coil shall then be rotated by 90 degrees in order to expose the EUT to the test field with different orientations.





### 4.7.6 TEST RESULTS

<b>TEST MODE</b>	See section 2.2	<b>TEST VOLTAGE</b>	See section 2.2
<b>ENVIRONMENTAL CONDITIONS</b>	21.7 deg. C, 52.6% RH	<b>TESTED BY:</b> Wang	

Magnetic field direction	Testing result	Remark
X - Axis	A	30A/m
Y - Axis	A	30A/m
Z - Axis	A	30A/m

**NOTE:** A: There was no change compared with initial operation during the test.

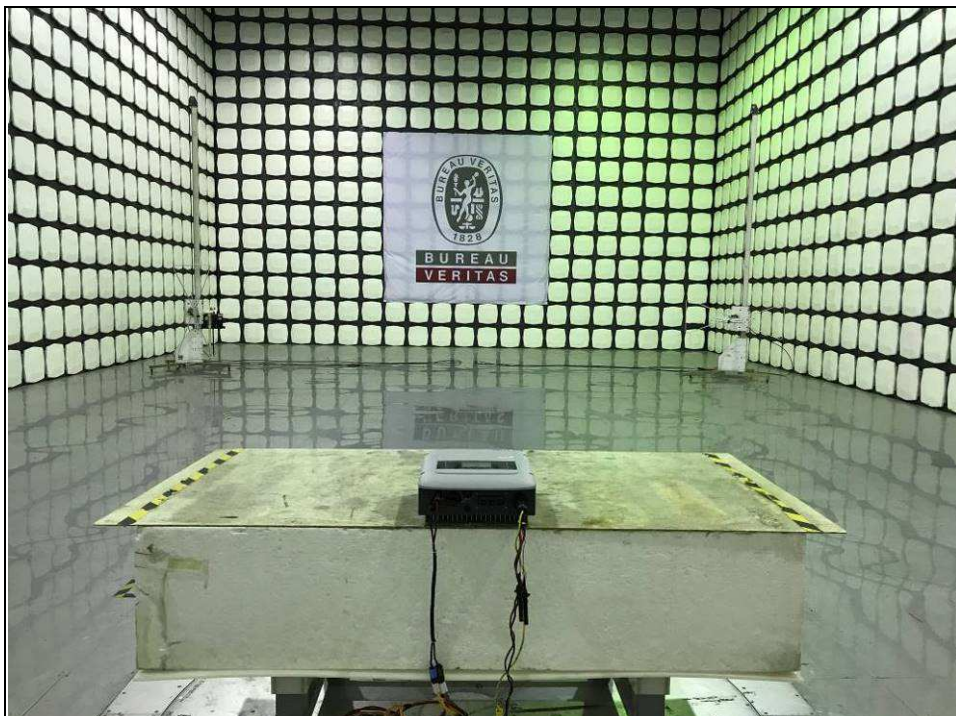


## 5 PHOTOGRAPHS OF THE TEST CONFIGURATION

### CONDUCTED EMISSION TEST



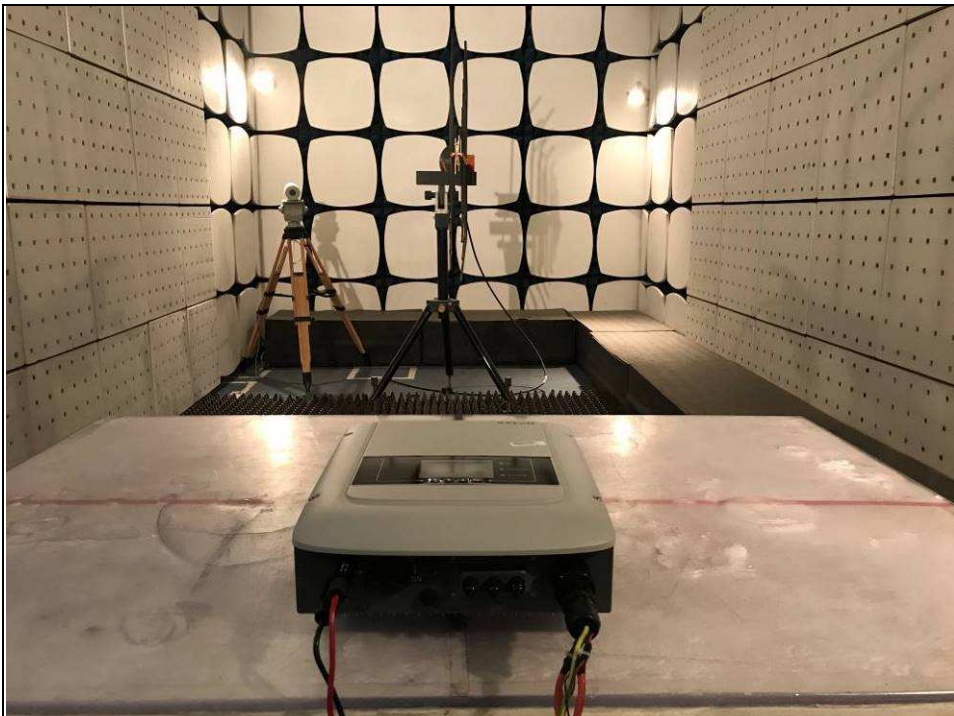
RADIATED EMISSION TEST (30MHz~1GHz)



ESD TEST



RS TEST



### EFT AND SURGE TEST



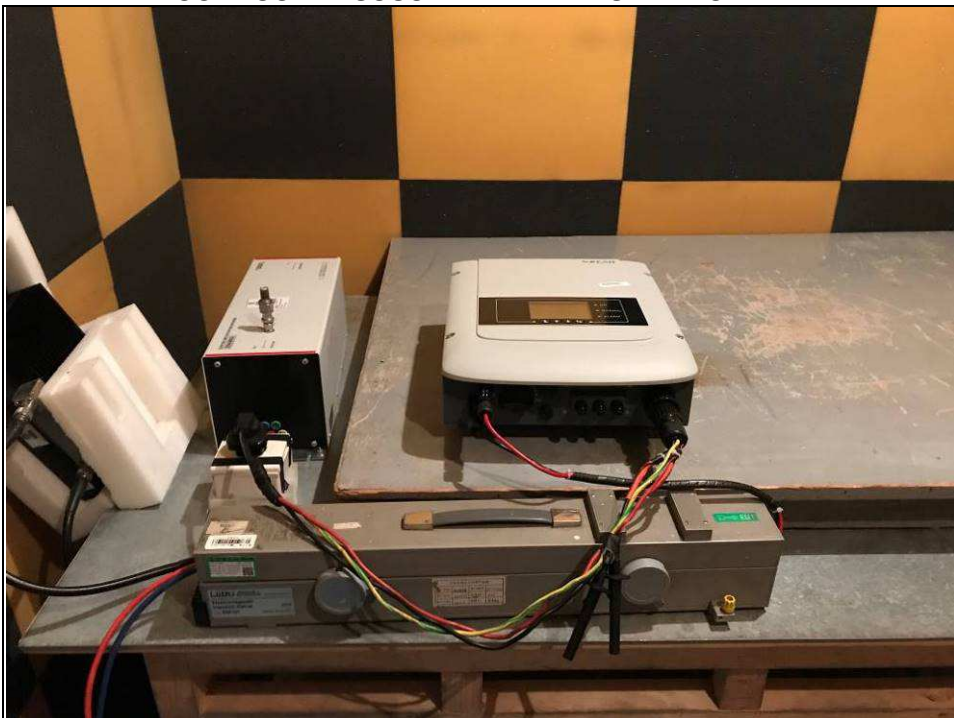
### EFT TEST AT DC LINE



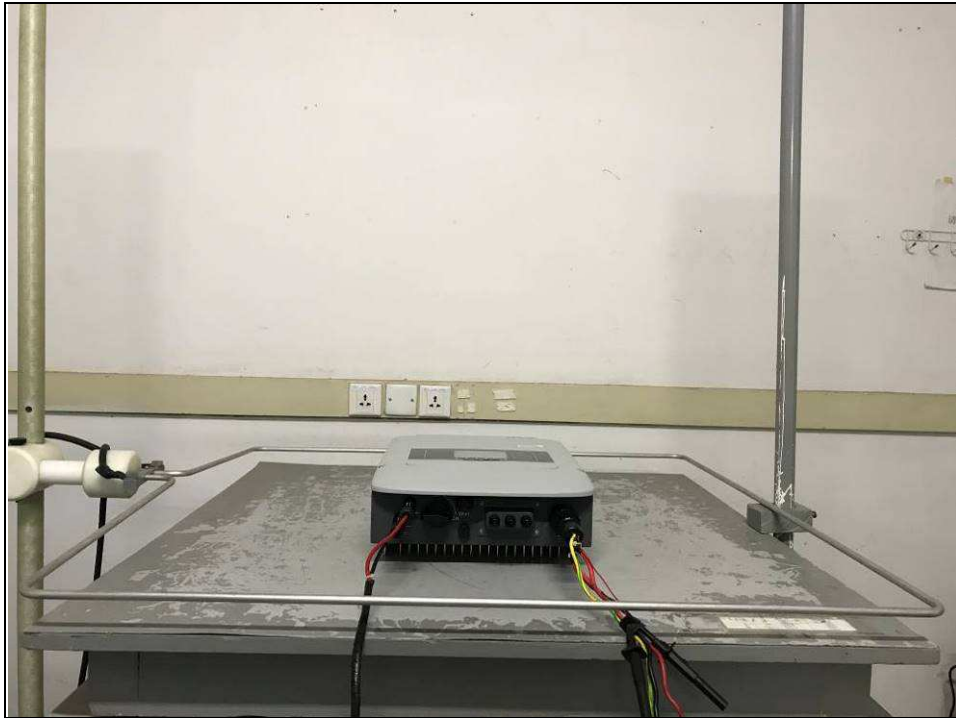
CONDUCTED SUSCEPTIBILITY TEST



CONDUCTED SUSCEPTIBILITY TEST AT DC LINE



POWER-FREQUENCY MAGNETIC FIELDS TEST





**BUREAU  
VERITAS**

Test Report No.: CE200423N070

## **6 APPENDIX A – MODIFICATIONS RECORDERS FOR ENGINEERING CHANGES TO THE EUT BY THE LAB**

No any modifications were made to the EUT by the lab during the test.

---END---